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EVALUATION OF SYSTEMVERILOG AND CONSTRAINED RANDOM VERIFICATION FOR DIGITAL DESIGNS

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FOREWORD

The purpose of this thesis was to evaluate verification methods for Field Programmable Gate Arrays with an aim to improve the testing of digital designs at Danfoss Drives. I want to thank the supervisor of this thesis, professor Jarmo Alander, and the instructor, MSc Petri Ylirinne, for providing valuable guidance and support throughout the process of writing this study. TABLE OF CONTENTS

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SYMBOLS AND ABBREVIATIONS

MHz	Megahertz
ms	Millisecond
ABV	Assertion Based Verification
AC	Alternating Current
AD	Analog to Digital
ADC	Analog to Digital Converter
ALU	Arithmetic Logic Unit
ASIC	Application Specific Integrated Circuit
AXI	Advanced Extensible Interface
BFM	Bus Functional Model
CDV	Coverage Driven Verification
CRV	Constrained Random Verification
DC	Direct Current
DMA	Direct Memory Access
DRMS	Discrete Root Mean Square
DUT	Design Under Test
FEC	Focused Expession Coverage
FIFO	First In First Out
FPGA	Field Programmable Gate Array
FSM	Finite State Machine

- HVL Hardware Verification Language
- IP Intellectual Property
- MMUR Memory Mapped User Register
- OOP Object-Oriented Programming
- PSL Property Specification Language
- PWM Pulse Width Modulation
- RTL Register Transfer Level
- SA Spectrum Analyser
- SoC System on a Chip
- SUT System Under Test
- SVA SystemVerilog Assertions
- TDD Test Driven Development
- TLM Transaction Level Modeling
- UVM Universal Verification Methodology
- VFD Variable Frequency Drive
- VIF Virtual Interface
- VIP Verification Intellectual Property
- VHDL Very High Speed Integrated Circuit Hardware Description Language

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The Field Programmable Gate Array is a device that consists of configurable logic, on chip-memory and often functionality that is fixed into silicon, such as hardware multipliers or transceivers for peripheral communication. The Field Programmable Gate Array is a configurable and reprogrammable digital circuit that can be designed to implement functionality that is deterministic and parallel. Due to these qualities the Field Programmable Gate Array is also an energy efficient choice of hardware for many digital designs.

Technological advancements in the semiconductor industry have resulted in a continuous decrease in transistor sizes, which in turn has allowed for an increased transistor density in semiconductor devices. For Field Programmable Gate Arrays the development has led to increasingly complex designs, as an increased amount of programmable resources are available. Consequently, the time and effort spent in verification of the digital designs has increased. Discovering design flaws before end products are released is not only economically crucial, but a failure to do so might damage the reputation of a company. In this thesis current verification trends are evaluated in three case studies made for Danfoss Drives. The objective of the thesis is to determine whether the quality of testing of Field Programmable Gate Array designs at the company can be improved by using Constrained Random Verification and the SystemVerilog language. Test benches for behavioral simulations are built using SystemVerilog in conjunction with the Universal Verification Methodology.

Constrained Random Verification based on the SystemVerilog language and the Universal Verification Methodology was evaluated for unit level testing in two case studies for one Intellectual Property core. A third case study was made for a system level design of multiple Intellectual Property cores as a SystemVerilog test bench utilizing neither constrained randomization nor the Universal Verification Methodology. Improved test coverage and an increased degree of automatization was achieved for the unit level testing, although at the cost of an increased verification effort. In the system level testing the capabilities of the SystemVerilog language proved beneficial, especially for creating transaction level stimulus, writing self-checking mechanisms for the test bench and modularizing its structure.

KEYWORDS: Field Programmable Gate Array, Verification, Constrained Random Verification, SystemVerilog, The Universal Verification Methodology

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Field Programmable Gate Array on laite joka koostuu ohjelmoitavasta logiikasta, sisäisestä muistista ja usein myös toiminnallisuudesta joka on kiinteästi sidottu laitteistoon, kuten kertolaskupiirit tai lähetin-vastaanotimmet ulkoista viestintää varten. Field Programmable Gate Array on konfiguroitava ja uudelleenohjelmoitava digitaalinen piiri joka voidaan suunnitella toteuttamaan toiminnallisuutta joka on determinististä ja rinnakkaista. Näistä ominaisuuksista johtuen, Field Programmable Gate Array on myös energiatehokas laitteistovalinta monen digitaalipiirin mallinnukseen.

Tekninen kehitys puolijohdeteollisuudessa on johtanut jatkuvaan transistorikokojen pienenemiseen, mikä puolestaan on sallinut suuremman transistoritiheyden puolijohdelaitteissa. Piireille mahtuvien resurssien kasvaessa myös Field Programmable Gate Array laitteiden mallit ovat monimutkaistuneet. Tästä johtuen, suunniteltujen digitaalipiirien verifiointiin kuluva aika ja vaiva on kasvanut. Suunnitteluvirheiden löytäminen tuotteesta ennen sen julkistamista ei ole valmistajalle ainoastaan taloudellisesti tärkeää, vaan saattaa epäonnistuessaan myös olla haitaksi valmistajan maineelle. Tässä tutkimuksessa ajankohtaisia verifiointitrendejä on arvioitu kolmessa Danfoss Drivesille toteutetussa tapaustutkimuksessa. Tutkimuksen tavoitteena on arvioida Painotetun Satunnaistamistestauksen ja SystemVerilog-kielen hyödyn Danfoss Drivesille toteutettujen Field Programmable Gate Array mallien verifioinnissa. Käyttäytmissimulointeja varten mallinnetut testipenkit toteutetaan SystemVerilog-kielellä käyttäen metodologiana Universal Verification Methodologya.

SystemVerilogiin ja Universal Verification Methodologyyn pohjautuvaa Painotettua Satunnaistamistestausta on arvioitu yksikkötestaukselle kahdessa tapaustutkimuksessa yhdelle Intellectual Property lohkolle. Kolmas tapaustutkimus on toteutettu järjestelmätason testaukselle useamman Intellectual Property lohkon järjestelmälle ilman painotettua satunnaistamista tai Universal Verification Methodologya. Yksikkötason testauksessa testikattavuuksia onnistuttiin kohottamaan ja Verifiointiin panostettu aika kuitenkin kasvoi. testiautomaation aste kasvoi. testauksessa SystemVerilogin kieliominaisuudet Järjestelmätason osoittautuivat hyödylliseksi, etenkin transaktiotason testisyötteen kirjoittamisessa, automaattisessa vasteentarkistuksessa ja testipenkin modulaarisen rakenteen mallintamisessa.

KEYWORDS: Field Programmable Gate Array, Verifiointi, Painotettu Satunnaistamistestaus, SystemVerilog, The Universal Verification Methodology

1 INTRODUCTION

The Field Programmable Gate Array, or FPGA, is a digital circuit that contains configurable logic blocks, on-chip memory and often functionality that is fixed into silicon, such as hardware multipliers or transceivers for peripheral communication. The configurable logic of the FPGA can be designed to implement functionality that is deterministic and parallel. As a result of this parallelism, FPGAs can achieve high throughput for data handling in tasks such as digital signal processing. An essential feature of the FPGA is that it is not only configurable, but also reconfigurable. Compared to conventional integrated circuit architectures, such as the Application Specific Integrated Circuit (ASIC), the FPGA offers a solution that is cheaper and faster to design (Maxfield 2004: xiii-xiv). On the other hand, the unit cost of an FPGA chip is generally higher than for a non-reconfigurable integrated circuit. FPGA designs are modelled using Hardware Description Languages (HDL), such as Verilog or the Very High Speed Integrated Circuit Hardware Description Language (VHDL). These languages have features to model concurrent behavior, which is most often synchronized by a clock. A processor, in contrast, is inherently sequential and performs tasks over multiple clock cycles. Although the processor generally achieves higher clock speeds than an FPGA, it usually underperforms in comparison with the FPGA when throughput, parallelism and energy efficiency is concerned.

A drawback of programmable logic is the effort that goes into modeling a functional design. Reduced transistor sizes have resulted in increased resource availability in FPGA chips, which in turn has allowed for a greater amount of design units and signals to be fit into a system-wide design. Consecutively, the complexity of the digital designs has increased. This trend has also affected the verification process. Verification, by definition, is the process of validating that a product or system meets the requirements and specifications that have been set for it. Verification is therefore an important part of quality control, and if done poorly, might be economically damaging for a company. For digital designs finding design flaws as early as possible is vital. In the development process a bug that goes unnoticed during unit tests is likely to be much harder to find once the tests move to the system level. In the worst case the bug is not found until the

product has been released onto the market, in which case the reputation of the company is in high risk to suffer. For safety critical designs there is an additional concern as there might even be life-threatening consequences of poorly performed verification.

The verification of FPGA designs can be performed as either testing with the real hardware, with the design running on the target device, or as a simulation that is performed in a simulator tool. The former has the benefit of being able to validate that the actual design works as intended. However, what hardware testing lacks is the visibility into the design. When a bug is discovered and the debugging work is started, the effectiveness of the process will be limited by the amount of signals that can be made visible through the external pins of the target device or by the amount of signals supported by an internal logic analyzer. Simulations, on the other hand, are generally capable of accessing all signals of the design, whether they are peripheral signals or internal to the design. Another benefit of simulation-based testing is the increased ability to model stimulus that extensively covers the functionality of the Design Under Test (DUT). For a simulation a test bench is made that resembles its counterpart in hardware testing - it creates stimulus to the DUT while also monitoring the response from it. The test bench of the simulation is, however, written as code and is not dependent on hardware. The challenge of simulation-based testing is, naturally, to create a test bench of good quality. A test bench can be considered of good quality if it stimulates the design with realistic stimulus, creates stimulus that extensively covers the functionality of the design and reliably reports the results of the response generated by the DUT.

The objective of this thesis is to evaluate the use of Constrained Random Verification (CRV) and the SystemVerilog language for simulation-based verification of FPGA designs. The methodology of choice for the CRV evaluation is the Universal Verification Methodology (UVM), which has become increasingly common for verification of ASIC and FPGA designs. Verification strategies will be made for the proposed verification methodologies, after which case studies will be performed for unit and system level testing. The goal of these strategies is to improve the quality of testing by suggesting methods that will raise test coverages while automating the test process. In order to establish a theoretical framework for this thesis, previously written papers related to eval-

uation of CRV methods are used for reference. Guidelines for writing the test benches of the case studies in this thesis have mainly been acquired from the *UVM cookbook* by Mentor Graphics (2012) and *SystemVerilog for Verification* by Chris Spear and Greg Tumbush (2012). The expectations for this thesis have been established by reviewing three theses that were all studies of CRV evaluation done with SystemVerilog. In all of these theses CRV testing was evaluated, either for a company or as a university study. The findings of these studies will be discussed in Chapter 2, where further information of the verification concepts of this study are presented. Finally, the feasibility of the verification strategies, the SystemVerilog language and CRV testing will be discussed. The results of the verification case studies will also be assessed.

2 THEORY AND BACKGROUND

A study of functional verification trends for ASIC and FPGA designs was conducted in 2016 by the Wilson Research Group. The findings of this study suggest that verification amounts to an increased percentage of the total time spent on both ASIC and FPGA designs (Mentor Graphics 2016). According to the study, in 2016 the amount of time spent on verification was 48% of the total amount of time spent on system implementation. Results from earlier years of the same study state that in 2014 the percentage of time spent on verification was 46% of the total time, and further back in 2012 it was 43%. Not surprisingly, this trend has also led to an increased number of verification engineers that are by average involved in FPGA projects. The average number of engineers per FPGA project was 6.6 in 2012, while in 2016 it had risen to 7.9. In 2012 only 2.6 out of the total 6.6 engineers were verification engineers. In 2016 the figure was 3.6 verification engineers versus 4.3 design engineers. However, although there is an increased effort into verification, bugs are still common. The study reveals that for safety critical FPGA designs, which can be assumed to undergo extensive verification, bugs escape into production in 75% of all cases. Another interesting finding by the study is that in 2016, 59% of all FPGA projects included one or more embedded processors.

The functional verification study also details trends related to the languages used for functional verification, the testing methodologies and the use of assertions. According to the study, as of 2016 SystemVerilog was the most preferred verification language. Among the methodologies, UVM, which defines a test bench architecture, as well as a set of classes and functions for it, has become the most popular verification methodology. In 2016, almost 50% of the companies participating in the study claimed to have used UVM in their test benches, and the projection for 2017 was that the percentage would rise over the 50% mark. Perhaps as a result of the increasing amount of companies that are implementing CRV methodologies such as UVM, the usage of code coverage and functional coverage, both of which will be discussed during this thesis, have also increased. Property checking assertions have also become increasingly common in verification. In 2016 the companies participating in the study claimed to have used assertions for over 45% of the FPGA designs they were verifying. In 2012 assertions were

used for only about 35% of the FPGA designs. The study suggests that the favored assertion language for FPGA designs is the SystemVerilog Assertions (SVA) subset of SystemVerilog.

Table 1. A summary over some of the FPGA-related findings presented in the 2016 Wilson Research Group study of functional verification trends. The asterisk sign denotes values that are approximations of chart table representations used in the study (Mentor Graphics 2016).

	2016	2014	2012
Percentage of the total FPGA system imple- mentation time that is spent on verification	48%	46%	43%
Average number of engineers involved in an FPGA project	7.9	7.8	6.6
Average number of verification engineers in- volved in an FPGA project	3.6	3.5	2.6
Percentage of FPGA design projects for which SystemVerilog is used in verification	47%*	38%*	31%*
Percentage of FPGA design projects for which UVM is used in verification	47%*	41%*	32%*
Percentage of FPGA design projects for which code coverage is used as a coverage metric	64%*	57%*	52%*
Percentage of FPGA design projects for which functional coverage is used as a coverage met- ric	56%*	54%*	42%*
Percentage of companies that have used asser- tions for FPGA verification	46%*	43%*	35%*

The functional verification topics covered by this thesis relate to FPGA designs in frequency converters manufactured by Danfoss Drives. The frequency converter is a device that converts an Alternating Current (AC) of one frequency to another. A common application target for frequency converters is between a power grid and an AC motor. In this setting the frequency converter is often called an AC drive or a Variable Frequency Drive (VFD), and it is used to adjust the speed of the motor by alternating its input frequency. There are several potential benefits of having optimal speed control for an AC motor, such as matching the power and torque requirements of a system or reducing mechanical stress on the machines in it. Another benefit of the AC drive is the energy saving potential it offers. According to Danfoss about 25% of all AC motors today are equipped with AC drives. Furthermore, the company estimates that for 40-50% of the motors not yet equipped with drives there would be a potential for energy savings if AC drives were installed (Danfoss Drives 2016). The basic operation principle of an AC drive is to rectify an AC, store it as Direct Current (DC) to a capacitor and then invert it back to AC with a desired frequency. One of the main tasks of the FPGA in frequency converters is to generate the Pulse Width Modulation (PWM) signal that is used to invert DC to AC. As the FPGA is a deterministic and parallel device it is suitable for this task. FPGAs are also used for other time-critical tasks of the drives, such as low latency communication between various nodes of the device. Valid behavior of the FPGA designs is therefore crucial for the overall performance of the AC drive. Faulty PWM generation could cause motor failure in AC motors connected to the drive, while logical bugs in communication logic could lead to distorted data or data being lost.

At this stage of the study, some assumptions of the coming work are made. These assumptions are based on observations that are made in three studies that were chosen as a reference for the evaluation done in this paper. According to one of the papers, constrained randomized tests were able to discover obscure bugs that would have been hard to find with conventional directed tests. In this study from 2008 a verification team at the company in question was evaluating the use of SystemVerilog with a CRV methodology that can be considered a predecessor to UVM. The verification team was able to achieve greater automatization of testing and was eventually finding bugs that would have been challenging to find with their pre-existing test methodology, which was based on self-checking directed tests. According to the study there were no time penalties during the introduction of these new methods, however, it must be stated that the company, Rockwell Collins, already had a verification team that was doing testing for safety critical designs. It can therefore be assumed that the verification was already at a reasonably high level (Keithan, Landoll, Logan & Marriott 2008).

In the second paper, which was written as a company evaluation case study for Nokia Networks, an introduction of CRV with UVM is presented. In this paper the writer describes the verification process for a co-processor designed by the company. Although the verification effort is not described in great detail, the impression is that for a designer with no previous knowledge of CRV and UVM there will be a learning process that

is time consuming. In the study a team of two engineers were verifying the co-processor for a time well over one year and the testing was still not complete. However, the DUT of the study is a system-wide design that can be considered complex. The writer's estimation is that at the time of writing the study, the time spent in verification is already greater than 50% of the total time spent on the system implementation (Ihanajärvi 2016).

The third paper referenced for this thesis describes an introduction to UVM for unit testing. The study provides valuable insight into what challenges may be faced by a designer that is new to UVM. According to the paper the biggest challenge was the implementation of verification components that require synchronization between the class-based test bench and the DUT. Nonetheless, the raised level of abstraction that comes with UVM was regarded as an advantage, especially for speeding up the creation of test sequences by hiding away low-level signal specific details of the test bench. In addition, it is concluded that after the initial challenges faced in the implementation of the first test bench, the following test bench implementations are significantly easier and benefit from the reusability provided by UVM (Francesconi, Rodriguez & Julian 2014).

One of the theorized challenges of creating CRV test benches is the DUT predictor model implementation. The predictor model, which is the self-checking mechanism of the CRV test bench, will be discussed further in Chapter 3.1.4. Nevertheless, it is essentially the component of the test bench that automates the checking of response against the predicted response. Based on the experiences of Francesconi et. al., the theory is that the creation of a predictor model that is completely synchronized with the DUT and faultless could for some designs be a challenging task that requires plenty of design effort. The challenge is not only limited to functional verification of digital designs, as in fact the *digital twin*, a digital model of a physical object or system, is a concept that has gained popularity throughout various fields of technology (Marr, Bernard 2017). Furthermore, another expectation for the work is that it will be challenging to define general rules for what is sufficient test coverage for a DUT. The role of functional coverage, which is a term related to Coverage Driven Verification (CDV), should be discussed in the context of the verification strategy together with code coverage. Although

the designs that are tested vary in their purpose, it would be beneficial to have metrics for what can be considered a sufficient amount of testing.

3 VERIFICATION CONCEPTS OF THIS STUDY

3.1 Constrained Random Verification and Coverage Driven Verification

The functional verification methods that are evaluated throughout this thesis are associated with two fundamental verification concepts – Coverage Driven Verification (CDV) and Constrained Random Verification (CRV). These two are linked with each other as they are often applied together. The definitions of these concepts are described in the following paragraphs.

In CDV the quality measure of the test is coverage. The idea of CDV is to create tests that cover as much of the DUT's functionality as possible, which is measured with *code coverage* and *functional coverage*. Code coverage, presented in Chapter 4.3, represents the implicit properties of the DUT, such as the amount of statements in the code that have been exercised throughout the simulation. Functional coverage, however, is explicitly defined by the designer of the test bench. Functional coverage should be based on the requirements of the DUT, and it is therefore unique for each verification environment. Functional coverage for a digital filter could be defined as a set of sine wave frequencies that have to be driven as stimulus to the filter in order to ascertain that the design was adequately tested. A communication protocol implemented in a digital design, however, requires functional coverage that is based on its protocol specifications. The Advanced Extensible Interface, or AXI, for example, has modes for single data word transmission and burst transmission, and therefore requires functional coverage for different transmission sizes (ARM Holdings 2018). Functional coverage will further be described in Chapter 5.3.

What is not defined by the CDV ideology, but what a successful implementation of it requires, is a method of being able to write a large amount of relevant test stimulus. This is where CRV complements CDV. In CRV the stimulus is randomized within limits that are specified by constraints. Throughout this thesis CRV will be used to refer to tests that not only utilize constrained randomization, but also fulfill the CDV principles.

The AXI-protocol implementation mentioned in the previous paragraph required functional coverage for its transmission sizes. In CRV a constraint could be defined as a range that corresponds to the length of data transmissions that are written to the DUT. The constraints are optional and can be specified for each variable in the test bench. In a CRV verification environment stimulus is randomized prior to each transaction, and if the stimulus has constraints, the randomization will conform to these. As randomization automates the stimulus generation, a randomized test bench is also able to drive a greater amount of stimulus than a directed test bench, in which the designer has written the stimulus manually. What a CRV test bench therefore requires is a self-checking mechanism for the response from the DUT. The self-checking component is usually implemented as a comparator that compares the predicted response of the DUT with the actual response received from it. Chapter 3.1.4 describes such implementations in more detail.

3.1.1 The Hardwave Verification Language features of SystemVerilog

A language that has become widely popular for verification of digital designs is SystemVerilog, which is based on the Verilog HDL language, but also includes language constructs that are intended for verification. In other words, SystemVerilog is not only a HDL, but also a Hardware Verification Language, or HVL. HVLs include features from high-level programming languages that are useful for the creation of test benches. As test benches do not have to be synthesizable, they do not have to be limited to the syntax of HDLs. HVL features are well suited to the CDV and CRV concepts, as functional coverage, for example, is supported by SystemVerilog through its use of cover-groups, cover points and cross-coverage. Randomization and constraints are also basic features of the SystemVerilog verification language. In SystemVerilog the test bench architectures are often associated with the use of Object-Oriented Programming (OOP). In object-oriented test benches classes correspond to verification components that all have a specified purpose. Furthermore, in these test benches bundles of signals representing interfaces are instantiated and handled as objects. Due to these properties, a test bench structure is achieved that is not only modular, but also reusable for designs with the same interfaces. This reusability has the potential of reducing test bench creation time.

Additionally, as bundles of signals are treated as objects in the test bench, stimulus can easily be written for transactions instead of single signals. This is well suited with the verification concept of Transaction Level Modeling (TLM) that will be described in Chapter 3.1.2. SystemVerilog also includes another beneficial feature for verification, which is unrelated to the features mentioned above: the SystemVerilog Assertions (SVA) subset language.

3.1.2 Transaction Level Modeling

TLM, in the context of verification, builds on the idea that stimulus is written to a bundle of signals concurrently, and that the randomization of these signals can be performed as one operation. The purpose of TLM is to create an abstraction layer that is above the signal level of the design. Digital designs that are modular, such as those that are built on IP-cores, often consist of interfaces of coherent signals. In verification of digital designs, identifying these interfaces of the DUT is a prerequisite for building transaction level object-oriented test benches, as transactions in these test benches are instantiated as objects.

Raising the abstraction layer not only makes it easier to simultaneously randomize stimulus, it also saves time during simulation (Bowyer 2006). In CRV test benches certain classes are modeled on the transaction level and are therefore not dependent on the cycle-accurate behavior of the DUT. Consequentially, the procedures of these classes are event-based and do not have to execute unless the specified event is triggered. Additionally, making test bench classes dependent on events rather than cycle-accurate behavior will arguably make the operations of the said classes easier to comprehend. The classes modeled on the transaction level naturally require that there is an underlying set of classes that handle the cycle-accurate behavior of the DUT. Instead, TLM better suits the DUT specifications that are written as higher level requirements, not as cycleaccurate behavior. In other words, the response from the DUT is not assumed to be of importance on every clock cycle of the simulation. Instead, in TLM test benches events are triggered by specified events of the DUT. The triggered test bench events can be related to self-checking of DUT response or coverage collection.

TLM requires that the self-checking component of the test bench is modeled on a higher abstraction layer than the DUT. The self-checker is therefore programmed with HVL features rather than as HDL code. The DUT functionality determines the level of effort that goes into modeling an equivalent predictor model of the DUT. For example, if the DUT implements an algorithm that was originally modeled and tested in a software language, the software model can be used as a predictor model in the test bench. In such cases the stimulus written to the DUT calls a function that updates the predictor model, which is then compared to the actual response received from the DUT. The predictor model exported from the original software implementation would therefore be reusable for the CRV test bench as it is modeled on the transaction level.

3.1.3 The Universal Verification Methodology

UVM is a methodology that implements the concepts presented in the previous subchapters of Chapter 3. The methodology is upheld by Accellera Systems Initiative, a standards organization, and is therefore not tied to a simulator tool distributed by one designated vendor. UVM defines a class-based test bench architecture that is intended to standardize the way that coverage driven constrained random test benches are built. In addition to defining a set of classes for the test bench architecture, UVM also defines a set of phases of testing, such as the build phase, the connect phase, the run phase and the report phase. Out of all UVM phases only the run phase consumes simulation time, and it is therefore the only phase that implements SystemVerilog tasks. The other UVM phases might for example build the test bench prior to the test and gather the coverage report after the test.

An example of a UVM test bench architecture is depicted in Figure 1. The block diagram contains classes that are generally found in UVM test benches. The exact architecture of a test bench will always depend on the DUT and its interfaces. The following paragraphs will describe the UVM classes in a bottom-up order.

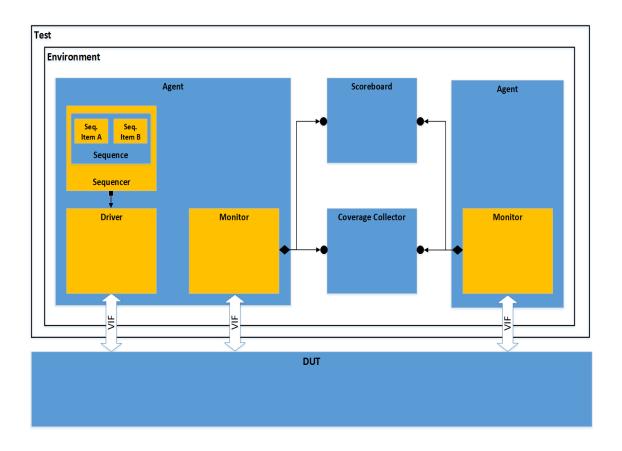


Figure 1. An example of a generic UVM test bench. The test bench resides within the *test* block and it communicates to the DUT via one or several virtual interfaces (VIF), here depicted as bidirectional arrows. The *environment* inside the test contains two *agents*, a *scoreboard* and a *coverage collector*. The leftmost agent contains a *driver*, a *monitor* and a *sequencer*. The sequencer further contains a *sequence* that is built on *sequence items* (Seq. Item A & Seq. Item B). The rightmost agent only contains a monitor and is called a passive agent as it does not drive any data to the DUT. The leftmost agent, by contrast, is an active agent.

The sequence item class is the container for variables that drive and receive DUT signals. Whenever a transaction is created, a new object of the class is instantiated. During the object instantiation the DUT input variables can be randomized. The DUT output variables, on the other hand, do not get randomized as their purpose is to store values that are received from the DUT. The sequence item class does not contain any other functions than its constructor, and it does not implement any tasks during the run phase of a UVM test. The sequence class is used to model sequences that consist of sequence items. For example, if a communication protocol implements a burst mode for data transmission, the sequence item could represent a data word and the sequence the complete data frame. A UVM sequence is usually parametrized with the type of sequence item it consists of. A sequence can only be built of objects of the parametrized sequence item class and objects of its extended classes. However, it is also possible that a sequence is built on other sequences. Such sequences are called nested sequences.

The sequencer is the container for sequences and sequence items. The sequencer is the class that is called when generation of sequences is desired, and it contains functions for transmitting the sequences towards the DUT. This class usually does not require actions by the designer of the test bench as its functions are provided by the UVM package.

The driver class receives sequences from the sequencer and drives them to the DUT. The driver converts the received sequences, one sequence item at a time, into signal level assignments that are driven to the DUT, after which it gives back control to the sequencer. The driver only drives signals to the DUT and does not monitor received response. An exception to this is handshake communication that requires that a response event from the DUT activates before subsequent signals can be driven to the DUT. Because the driver operates on the signal level it is a part of the UVM test bench environment that is cycle-accurate. The driver therefore contains a task with clock-synchronized logic. The logic of the driver depends on the functionality of the DUT interface that it communicates with.

The monitor class is a component of the UVM test bench that monitors communication to and from the DUT. The monitor also operates on the signal level, however, it usually only triggers on certain events. A triggering event activates assignments that write data to a monitoring stream. The assignments write signal values from the virtual interface to variables of the test bench. In UVM the monitoring stream that is connected to a monitor is known as an *analysis port*. The analysis port is connected to classes in the test bench that handle monitored data. The receiving end of an analysis port is called an

analysis export. A monitor never drives data to the DUT and it can contain multiple analysis ports that are triggered by separate events.

The classes mentioned so far are all contained in an agent class. In UVM the agent is intended to be a reusable verification component and therefore it is recommended that the classes inside it are designed in a generic manner that allows for reuse. The agent is only a container class and its only purpose is to build the components inside it and route analysis ports to its outer boundary. An agent can be either active or passive. An active agent contains a driver and a sequencer while a passive agent does not. The latter can be used for example if an internal signal of the DUT is monitored with a SystemVerilog *bind* statement and used for coverage collection. Figure 1 contains an active and a passive agent.

The class that encapsulates UVM agents is called the environment. The role of the environment, similarly to the agent, is to build classes inside itself but also to connect analysis ports from outer boundaries of agents to analysis exports of other classes contained within itself. Classes that are not suitable for reuse are generally placed in the environment instead of being placed inside the agents. In the block diagram of Figure 1 two such classes are present in the environment.

The scoreboard class implements the self-checking of the test. It compares the response of a predictor model with the actual response of the DUT. The predictor model is an equivalent of the DUT that is generally modeled on a higher level of abstraction than the real design. It can be considered as the golden reference for the design that conforms to the design specifications. The predictor model can either be implemented inside the scoreboard or it can be an independent class outside of it. In Figure 1 it is assumed that the predictor model has been implemented internally. The scoreboard can be connected to multiple agents, as can be seen in Figure 1, and it has several methods for handling monitoring events. The functionality of a UVM scoreboard will be described in more detail in Chapter 3.1.4.

In addition to the scoreboard, the environment depicted in Figure 1 also contains a coverage collector. While UVM does not actually define a coverage collector class, it has been named so in Figure 1 for clarity. The UVM cookbook by Mentor Graphics presents two UVM classes that are suitable for coverage collection: the *subscriber* class and the *component* class (Mentor Graphics 2012). The subscriber class extends the component class and offers a simplified method for writing monitored data from one monitor to the coverage collector. The subscriber implements a *write*-function that is automatically called whenever monitored data is received. However, the subscriber is restricted to only one monitoring stream. For coverage collectors that require multiple monitoring streams the UVM cookbook recommends the use of the component class. The coverage collector is the class that contains the SystemVerilog covergroup, coverpoint and cross-coverage statements that gather functional coverage during a test. Whenever a transaction is received from a monitoring stream the functional coverage is updated.

The final class to be presented in this chapter is the test class. The test class is a container for the environment class, which it builds prior to the run phase of a test. Once the simulation proceeds to the run phase, sequencers contained within the agents of the environment are called from the test class. In UVM test completion is controlled with *objections*. Generally, an objection is raised before the sequencers are started in the test class, and dropped once all sequencers have finished their stimulus generation. A dropped objection signals the UVM test bench to proceed from the run phase to its following phases, at which point test reports are gathered and written to files.

3.1.4 Self-checking test benches

A successful UVM test requires a self-checking component that automates the task of checking the validity of the DUT response. When building the test bench the self-checking activities of it are arguably the most challenging to design. For the implementation of the predictor model there are not many common guidelines, as the DUT implementations are all unique. What can however be generalized are the methods of how to store the predicted responses, when to trigger a scoreboard comparison and how to do

it. All of these depend on the nature of the transaction stream from the DUT. When designing a self-checking test bench it is important to identify the conditions for when a scoreboard comparison should be made. In this chapter three useful methods for different types of DUTs are presented in Figures 3-5. In the figures the predictor models are not shown and are assumed to be separate from the scoreboards. However, the predictors can also be implemented internally into the scoreboard, in which case the predicted response in the figures would arrive from an internal predictor.

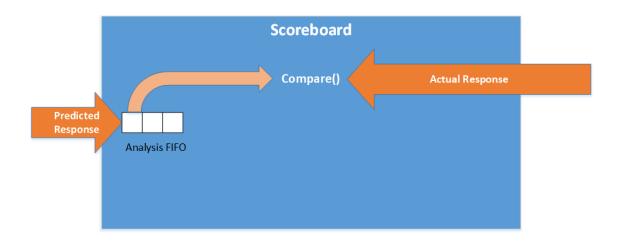


Figure 3. An In Order Scoreboard. A transaction that is written to the DUT results in a predicted response, which is stored in an *Analysis FIFO* in the scoreboard. Once the actual response of the DUT is received, it triggers a comparison with the predicted response. The predicted response is popped from the Analysis FIFO upon being triggered by the actual response.

Figure 3 depicts an In Order Scoreboard for which the order of stimulus and response is known. In its simplest form the scoreboard contains one Analysis FIFO for the predicted response. In this model the Compare-function is called once the response is received from the DUT. If multiple transactions have been stored in the FIFO, the one that was stored first in the buffer is popped. An example use case for the In Order Scoreboard could be an Arithmetic Logic Unit (ALU) that calculates the sum of two numbers.

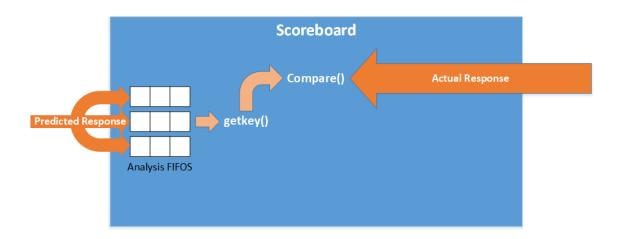


Figure 4. An In Order Array Scoreboard. In this model a transaction that is written to the DUT results in multiple predicted responses, which are all stored in their own Analysis FIFOS. Once an actual response is received from the DUT, a getkey-function is called that determines from which Analysis FIFO a predicted response is retrieved. The predicted response and actual response are then compared.

Figure 4 depicts an In Order Array Scoreboard. This scoreboard type differs from the In Order Scoreboard in that a stimulus results in multiple responses. Using the ALU for the In Order Scoreboard as an example, the In Order Array Scoreboard could be used for a variant of the ALU that calculates the sum, difference and product for two given numbers in parallel. If the ALU only has one output signal for the data, it must contain an additional signal that indicates which operation was performed for its current output. This additional signal would be used in the getkey-function of the scoreboard to determine which Analysis FIFO containing predicted response is popped.

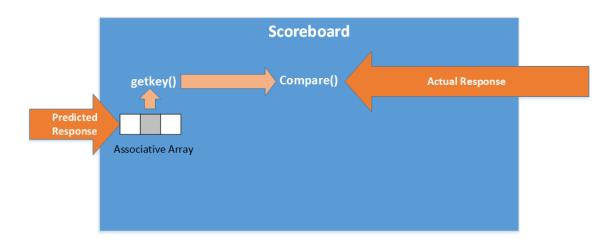


Figure 5. An Out Of Order Scoreboard. In this model the Analysis FIFO of the predicted response has been replaced by an Associative Array. The Associative Array is used as the order of the predicted responses is unknown. Once an actual response is received from the DUT, a getkey–function is called that retrieves a predicted response from the Associative Array. The predicted response and actual response are then compared.

Figure 5 depicts an Out Of Order Scoreboard for which the order of incoming DUT responses cannot be predicted. The Out Of Order Scoreboard utilizes SystemVerilog Associative Arrays instead Analysis FIFOs. Associative Arrays have the benefit of being indexable by types other than integers, and additionally, Associative Arrays do not allocate memory at instantiation – memory is allocated whenever an entry is written to the array. For the Out Of Order Scoreboard the ALU of the previous two paragraphs is no longer a valid example. A design that would require an Out Of Order Scoreboard could be one that contains a buffer for incoming transactions and a state machine that controls the processing of data. If the test bench has no visibility into the design, which is usually the case with UVM test benches, it may not have any knowledge of which of the buffered transactions in the DUT are being handled. Consequently, once a response arrives from the DUT, all of the predicted responses have to be checked for equivalence. In an Associative Array the predicted response could be stored into slots that are indexable by enumerated types. The indices could be for example {valid, buffer_overflow, protocol_error, data_error. The getkey-function that is called once a DUT response is received would return the type of predicted response that needs to be checked. Each slot in the Associative Array could further contain an array that allows for multiple predicted responses to be active for each enumerated type. If a valid output would be received from the DUT, all predicted responses inside the *valid* slot of the Associative Array would be checked. If no valid entries exist in the Associative Array, an error would be raised.

3.2 Temporal Logic verification

In addition to verification on the transaction level, verification can also be performed at a lower level of the design with temporal logic statements. Temporal logic verification is the validation of a design's behavior in terms of time, which in digital designs most often is related to a clock. The following two statements are examples of temporal logic. "I am tired until I rest" and "If I don't eat I will eventually get hungry". The words "until" and "eventually" are modal operators that specify a relation in time between the first part of the statement and the second part of the statement. A digital design can similarly be described by statements that should always, eventually or never hold true. Furthermore, statements can be combined to form layers of temporal logic, for which the valid-ity can be checked with *assertions*. In this thesis verification for temporal logic will not be evaluated, however, as research shows that assertions have become increasingly common in digital design verification, it was decided that an introduction to this topic would be provided. Assertions have been used in conjunction with CRV testing to enhance the quality of testing, and therefore assertions will be discussed in Chapter 8 in the context of potential future research. Two publications are used for reference

In verification of digital designs or software temporal logic is regarded as a type of formal verification. Common languages used for temporal logic verification of digital design are the Property Specification Language (PSL) and the SystemVerilog subset language SystemVerilog Assertions (SVA). The languages are similar in that they both define a layered structure for modeling a design behavior, often illustrated as a pyramid. An illustration will be given in Figure 6. In both languages the bottommost layer is a Boolean layer that defines statements such as *A and B*. Boolean statement by adding a time relation to it and making an assertion of the resulting temporal statement. In Chapter 3.2.1, an SVA assertion is demonstrated. In this thesis two publications are used as reference on Assertion Based Verification (ABV)(Foster, Krolnik 2008)(Foster, Krolnik, Lacey 2010).

3.2.1 SystemVerilog Assertions

SVA is an assertion language that has gained popularity in digital design verification. It separates assertions into two types: *immediate assertions* and *concurrent assertions*. Of these two types the former is a non-temporal assertion while the latter is temporal. Immediate assertions can only be placed within procedural statements, such as always-blocks in SystemVerilog, and they evaluate in zero-time. Concurrent assertions, in contrast, are evaluated over several clock cycles and can be triggered by a certain condition. Out of these two types of assertions, the concurrent assertions are of greater interest for in this study. Assertions, whenever referenced from now on in this study, are therefore assumed to be of the concurrent type.

As described in Chapter 3.2, SVA defines a layered structure for building assertions for temporal statements. The structure is depicted in Figure 6 below.

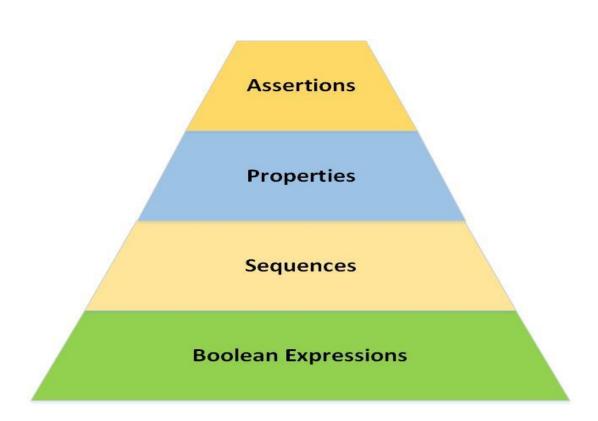


Figure 6. An illustration of the temporal layers of SystemVerilog concurrent assertions. The bottommost layer defines boolean expressions without time relations. The layer above expands the boolean expressions by creating event sequences of them. The event sequences are specified in terms of clock cycles. Sequences are further used by properties on a layer above. Properties can also be built on properties consisting of sequences. On the topmost layer assertions are made of properties.

The following paragraphs will give an example of an assertion that is built by the multilayered approach. The example describes a handshake protocol with a request and acknowledge signal. The concurrent assertion is based on the timing diagram of Figure 7.

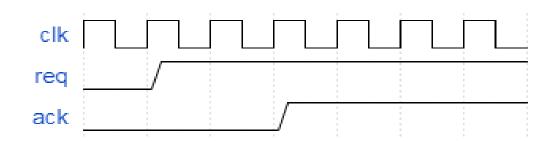


Figure 7. A timing diagram of a handshake protocol. When the request signal req rises, the acknowledge signal ack must rise after two clock cycles.

The Boolean expression of this concurrent assertion is not actually necessary, but it will be defined explicitly in this example. The Boolean expression is described by the following line of code.

req == 1

The Boolean expression can also be simply expressed as req. The following lines of code describe the sequence that is built on top of the Boolean expression. The sequence states that the ack signal must be asserted two clock cycles after req is asserted.

```
sequence req_ack_seq;
    req ##2 ack;
endsequence
```

The layer above the sequence layer makes a property of the above sequence. The resulting property is described by the following code segment.

```
property handshake;
  @(posedge clk) req_ack_seq;
endproperty
```

The property defined above evaluates the sequence that was modeled on the positive edge of the clock. Below is the code segment that makes an assertion of this property.

handshake_assertion: assert property(handshake)
 else \$error("Handshake error");

A concurrent assertion and its underlying temporal statements can either be defined in an interface or a module.

3.2.2 Assertions used as protocol checkers

Assertions are valuable in verification whenever design behavior can be described in detail on a cycle-accurate level. The use of assertions therefore requires a knowledge of the design often only possessed by the designer of the DUT. Design documentation of an IP rarely describes the design in detail with timing diagrams that can be used to model assertions. However, interfaces are usually well understood as documents generally contain their timing information. Consequently, assertions can be modeled for these with a relatively small effort and be used as checkers that monitor interaction between the modules of an individual IP-block or the interaction between IP-blocks in a system level design. These checkers increase the visibility into the DUT and may be beneficial for discovering the root cause of a bug. In a test bench without assertions the debugging process arguably requires more effort as the problem cause must first be established before the design can be fixed.

3.2.3 Using assertions to complement test benches

Assertions can be used to complement CRV test benches, but if assertions are used in conjunction with a UVM test bench, they must be defined outside of the UVM classes. An assertion IP can be made of a module, or alternatively the assertions can be placed inside a SystemVerilog interface. While the UVM scoreboard checks the response of the DUT on the transaction level, the assertions can check cycle-accurate behavior. The assertions can be of additional value as they can be used to off-load some of the check-ing that would otherwise have to be implemented in the predictor model. Assertions could also be made during the design phase of the DUT by the designer that has knowledge of the IP.

Assertion IPs can also be used together with test benches created in Verilog or VHDL if a simulator tool is used that supports concurrent assertions. Verilog and VHDL do not have concurrent assertions and are therefore limited to assertions in procedural blocks. Presumably many companies already have an existing system level test bench that is implemented in one of the two aforementioned languages. In such case assertion IPs can be added to the testing without any modifications to the existing test bench. The assertion IPs can be instantiated as additional test bench modules that are simulated in parallel with the top-level module of the system level test bench.

4 PRESENT TESTING METHODS OF THE COMPANY

4.1 Simulation-based test types in use

At Danfoss Drives the FPGA design team implements three types of simulated tests: the IP-block level test, the system level test and the release test. Out of these three tests only the first two will be covered with case studies in this paper. The release test, which will be excluded from this thesis, is a test that is applied to a system level design before it is handed over to the software team. At present, the purpose of this test is not to extensively test the behavior of the design, but to perform directed tests at features that are known to cause problems in the integration phase of the firmware on the embedded processor and the FPGA. An example of such a feature is the polarity of the *reset*-signal. However, the actual test coverage of the FPGA designs is gathered by the IP-block level test and the system level test. The latter validates the behavior of a system level design that contains multiple IP-blocks. Before an IP-block is tested in the system level test it is assumed that it has already been tested with an IP-block level test bench. The system-level test will also be referred to as the integration test throughout this thesis.

The lowest level of testing is performed at the IP-block level. The IP-block can consist of one or several modules, but it's the smallest unit of reusable logic in an integrated digital design. In the context of testing, the IP-block is easier to test than an integrated system. Apart from containing less logic and having better interface access into the design, the IP-block usually implements a function that is clearly defined. It is also in general easier to gather extensive coverage for an IP-block than during a later phase in the system level test, as the simulation time of an IP is likely to be less than for a larger design. It is customary that the designer of the IP-block, or one of its designers, writes the design specification for the IP-block in question. As the IP-block level test is considered a part of the design process, it is usually implemented by one of the designers responsible for the Register Transfer Level (RTL) logic of the IP.

4.2 Verification methods in use

The tests described in Chapter 4.1 are written in the VHDL language and are mostly performed as test cases with predefined stimulus for which results are validated with VHDL assertions. Procedures and functions are used to generate reusable code for recurring tasks such as generic write and read tasks for certain interfaces. For such interfaces the level of abstraction can be considered to have been raised to the transaction level. Randomization with VHDL has been used for some tests, but in general the current testing methodology can be reviewed as directed testing (Bartley, Galpin & Blackmore 2002). In directed testing the DUT is driven to states with known responses. The behavior for the intended functions of the DUT are known by the designer and should also be documented in the design specification. With directed tests so called corner cases of the design's behavior are generally targeted with dedicated test cases. Corner cases of a design can usually be predicted as they are cases for which bugs are likely to be found. An example of a corner case is the overflow condition for a buffer. As the sequence of events is known in directed testing, and the amount of driven stimulus is generally less than for a random stimulus test bench, debugging also requires less effort than for a randomized test. If extensive coverage of the design is desired, however, the amount of test cases will increase and cause an overhead in the effort required for designing and maintaining the test bench. Directed testing is also potentially hazardous as bugs may remain uncovered for obscure DUT behaviors.

The test benches of the FPGA design team usually consist of a series of test cases that target some functionality of the design. The amount of test cases depends on the complexity of the design. The system level test bench, which has been expanded over time as more features have been designed, currently consists of approximately 30 test cases. For reporting test results, code coverage, which will be described in Chapter 4.3, has been introduced as a metric of testing quality. Code coverage is not intended to indicate whether certain design requirements have been validated through testing or not, it is merely used as an approximation of how much of the RTL code of the design has been covered by the test. The coverage in terms of functionality is currently not reported.

4.3 Test reporting with code coverage

The test results are reported for each IP-block as a percentage of achieved code coverage. The code coverage of an IP-block is the combined sum of the coverage gained from the IP-block test and the system level test, which the simulator tool is able to merge. The tool does not raise the total coverage if there are overlaps in covered features, and for example, a statement that is executed in multiple tests is only added once to the total statement coverage. Code coverage is a concept that defines a set of metrics that are measured during a simulation of software, or in this case RTL code. The code coverage that is measured by the FPGA design team at Danfoss Drives is presented in the following paragraphs. As there are variations between the definitions provided by the vendors of the simulator tools, it is worth to notice that the definitions presented here are derived from the Questasim User Manual written by Mentor Graphics (Mentor Graphics 2015: 815-843). The Questasim simulator is the simulator tool that is used during the evaluation of the CRV tests presented this thesis.

Statement coverage counts the execution of statements in the source code. Statement coverage resembles line coverage, with the difference that a line in the source code can consist of several statements. The Mentor Graphics simulators Modelsim and Questasim do not measure line coverage, only statement coverage.

Branch coverage counts the execution of branches in if/else and case branch statements. An if-statement with multiple nested else if-statements and an else-statement must have all of its branches executed at least once in order to have been fully covered by branch coverage.

Toggle coverage, in standard mode, regards signals in HDL source code as bit vectors and counts the amount of times each bit has been toggled from 0 to 1 and from 1 to 0. There is also an extended mode of toggle coverage for tri-state signals. These signals have an additional state – the high impedance state Z. The extended mode counts all variations of toggles between 0, 1 and Z. The toggle coverage that is used by default by the FPGA design team at Danfoss Drives is the standard mode.

Finite State Machine coverage counts the amount of times each state and state transition of a Finite State Machine (FSM) has been executed. FSM coverage is useful in RTL design verification as it might reveal logical bugs related to FSMs. Common FSM related bugs include states that are unreachable and state transitions that cannot occur.

Condition coverage counts the execution of each variation of a subexpression in a condition statement, such as an *if-statement*. For example, the following *if-statement* written in VHDL contains a subexpression, where signals A and B are one-bit wide signals.

The subexpression A and B contains two bits and therefore has four unique input entries. A condition coverage of 100 % would require that all of these have been covered during the simulation. However, an increased amount of input bits leads to an exponential increase in the amount of unique input entries. Standard condition coverage is therefore not an option for subexpressions consisting of bit vectors. As a solution, several vendors offer *Focused Expression Coverage (FEC)* as its default condition coverage. This is also the case with Modelsim and Questasim, the tools used at Danfoss Drives. The following definition of FEC is cited from the Questasim User Manual.

In FEC, an input is considered covered only when other inputs are in a state that allow it to control the output of the expression. Further, the output must be seen in both 0 and 1 states while the target input is controlling it. If these conditions occur, the input is said to be fully covered. The final FEC coverage number is the number of fully covered inputs divided by the total number of inputs (Mentor Graphics 2015).

If a conditional statement contains an expression that consists of several subexpressions, FEC makes a simplification of the full expression before it evaluates each input. For

example, in order to evaluate the FEC condition coverage of input A in the following VHDL if-statement, the expression is first simplified.

if(A and B and C and D)then

The simplified statement of the above if-statement is

```
if (A and Expression 1) then
```

The logic expression B and C and D has now been reduced to Expression_1. In order to fully cover input A, Expression_1 must be true. When the expression is true, A has exclusive control over the output. Input B is according to the principle of FEC only evaluated when A is true, as the evaluation of the conditional statement moves from left to right. The FEC condition coverage for B is therefore evaluated with the following simplified statement, assuming that A is true.

if (B and Expression 2) then

In the above statement Expression_2 corresponds to C and D of the original expression.

Expression coverage is the last of the coverage metrics generated by Questasim and Modelsim that is used by the FPGA design team. Expression coverage is similar to condition coverage, except that the statement is a Right Hand Side (RHS) statement of a signal assignment, such as in the following example written in VHDL.

 $A \leq B \text{ or } C \text{ and } D;$

The same problem occurs with expression coverage as with condition coverage. The state space for the input entries can be too vast to cover if the inputs are bit vectors. Expression coverage is therefore by default also gathered as FEC in Modelsim and Questasim.

5 VERIFICATION STRATEGY

In this chapter verification strategies for the IP-block test and the integration test will be presented. The presented strategies are intended as guides for creating tests that are based on the functional verification methodologies presented in this thesis. The strategy defines what kind of tests are performed for either the IP-block or the integrated system, what the objective of each test is, how self-checking is implemented and whether ran-domization and functional coverage is used. Three strategies are introduced in total – two for the IP-block test and one for the integration test. The presented strategies assume a bottom-up order of verification, in which an IP-block is tested before the integration test is performed.

5.1 Verification strategies for the IP-block test

The proposed strategies for IP-block testing are based on a black-box approach and are implemented as CRV test benches, UVM being the methodology of choice. In blackbox testing it is assumed that the internal functionality of the DUT is non-visible. Therefore, the verification is performed on a higher level of abstraction that only validates the behavior of the DUT through its peripheral signals. White-box verification, on the other hand, assumes that the internal functionality of a design is visible. In white-box verification the behavior of the DUT is validated on a lower level of abstraction within the DUT and on its periphery.

The structure of a generic IP-block is depicted in Figure 9. It will be used as a baseline design for which the verification strategies of the IP-block tests are implemented.

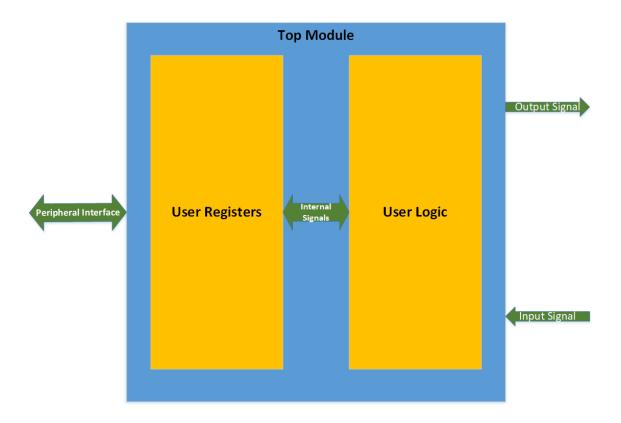


Figure 9. An example of a generic IP-block that contains a submodule for user registers and a submodule for user logic. The peripheral interface, if one exists, usually interacts with the user registers of the IP. The user logic acquires configurations from the user registers through internal signals of the IP. Input and output signals not part of a peripheral interface may also be mapped from the top module directly to the user registers or the user logic.

5.1.1 Full IP test bench

In the first proposed strategy the full IP-block will be regarded as the smallest unit that is tested. In designs that interact with software of an embedded processor, IP-blocks can be accessed through a peripheral interface that is usually based on a protocol such as AXI. A commonly used practice is to configure the IP-block from the software with write operations to the user registers of the design. Additionally, if the IP is a coprocessing block that is used in conjunction with processes in the software, registers of the IP-block are read by the software, usually by polling the status registers of the IP. The input and output signals of the DUT that are not a part of its peripheral interface are routed to other IP-blocks in a system-wide design and are therefore not necessarily accessible by the software. The full IP test bench implements a predictor model for the user logic of the IP that also contains a register model for the user registers in the IP.

In Chapter 3.1.4 fundamental self-checking mechanisms of CRV methodologies were introduced. Common for all self-checkers is that there must be a condition that signals the start of an event and another condition to signal a finalized event. The latter will here be referred to as the stop condition. For an IP-block such as the one depicted in Figure 9, the start and stop conditions can be obscure as they are marked by signals that are hidden inside the DUT. A challenge that was encountered at the start of the thesis work was indeed related to these signals. A full IP test bench sends a transaction to a user register that signifies the start of an event. However, the actual start condition can be received by the user logic of the DUT after a delay of a few clock cycles. As the predictor model of the test bench must be synchronized with the DUT in order to be valid, the delay before the event is registered by the predictor model must be equivalent to the delay inside the DUT. This will inevitably mean that the designer of the test bench must have timing specific knowledge of internal logic of the DUT. What can potentially present an even greater challenge for the verification engineer, however, is the stop condition. In designs with a similar design hierarchy as the one depicted in Figure 9, the test bench must poll a status register of the IP that contains a bit that marks a finalized event. Furthermore, if the bit is asserted and the event was finalized, the design might require that one or several user registers containing data are read before the test bench prediction and actual response can be compared. If the test bench stimulates the DUT with a known sequence of transactions, the comparison of the prediction and the response can be triggered from a predetermined read operation that reads the last data item that is required for a comparison. However, if the test bench stimulates the design with a randomized sequence of transactions, the test bench must implement a checking mechanism that assures that a start condition has preceded a stop condition, and that after the stop condition has occured, all registers containing response data must be read before the comparison is performed in the test bench. Consecutively, the complexity of the predictor model in the test bench increases, and with it the time required to design the test bench.

As the write and read operations to the user registers control the behavior of an IP such as the one depicted in Figure 9, limitations can be made for what stimulus would realistically be written to the design. It is therefore proposed that the sequences of the full IP test bench are not fully randomized but split into dedicated test cases. Data can still be randomized as well as the occurrence of certain stimulating events, but the sequencers of the test bench will be more constrained. For example, randomized toggling of the reset signal can be left out of most tests cases. Also, randomized write operations to user registers of the design can be implemented in one dedicated test. Table 1 describes test cases that are generic and that could be implemented instead of one fully randomized test.

Test type	Purpose of the test
User register write/read test	Verify that the write and read rights to the user registers of the IP conform to the de- sign specifications
Reset test	Verify the behavior of the DUT after a re- set condition occurs. The reset can occur at a random time during an active event.
Reconfiguration test	Verify the behavior of the DUT after user register configurations are changed during an active event.
Data error test	Verify the behavior of the DUT when an input is received that contains erroneous data.
Protocol error test	Verify the behavior of the DUT when an erroneous message is sent to a communication bus of the DUT.
Buffer overflow test	Verify that the DUT can handle buffer overflows that are caused by peripheral communication.
Base test	Verify the behavior of the DUT under normal conditions, if such conditions can be specified. For a co-processing IP that communicates with software the transac- tion sequence might follow a predeter- mined order.

Table 1. Examples of generic test cases that can be implemented by the proposed full IP test bench.

5.1.2 Divide and conquer test bench

Another testing approach that is proposed as an alternative for the full IP test bench is the divide and conquer method. In this method there are three separate test benches: one for the user registers of the IP, another for the user logic of the IP and a third for the full IP. The idea is that the DUT can be tested more extensively with the user register and user logic test benches, and that the final full IP test bench only implements trivial test cases that validate correct mapping of signals within the IP. The stimulus written in the final full IP tests could be predetermined, therefore not requiring a register model and predictor model. Although the divide and conquer method requires several test benches, it assumedly requires less effort for creating the predictor model. It is also theorized in this thesis that it will achieve higher coverage of the DUT than the full IP test bench. This is due to the fact that the fully randomized test should be able to explore a greater amount of the state space than tests that are constrained to predetermined event sequences.

The user logic test bench is where most of the design will be covered. In the previous chapter the visibility challenges of the full IP test bench were presented. Because the user logic module has input and output ports that are mapped to the user registers of the IP, one of them being the signal that marks a finalized event, it is proposed that the user logic test bench should stimulate the DUT with a randomized sequence of transactions. This type of randomization can drive the DUT into a state that uncovers unpredictable logical bugs. The user logic test bench simplifies the comparison between the predicted response and the DUT response – the comparison can be made as soon as the stop condition is easier to validate as the responses are visible in the output ports of the DUT. In the full IP test bench the user registers would have to be read one by one after a reset has occurred.

The divide and conquer method also includes a user register test bench. This test bench contains a register model that is based on design specifications. The purpose of the register model is to validate write- and read-rights to the registers. The register model can also contain registers that are self-clearing or read-only. In this test bench fully randomized write or read operations are driven to the DUT, and the comparison can occur either when a read operation has been performed or after a fixed amount of clock cycles has passed since a write operation. If the aforementioned comparison scheme is chosen, the comparison is only made for the register that was read. If the latter is chosen, the whole register model is compared to the output ports of the user register module. This comparison scheme requires that all user registers are mapped to output ports in the user register module.

After having tested the user logic and user registers separately, the divide and conquer method still requires a test bench for the full IP-block with a few directed test cases. The purpose of the tests in this phase is not to raise coverages, only to validate that signals from the user logic and user registers are mapped correctly and accessible by the top module. Once these tests have been completed the coverages of all tests in the three test benches can be merged.

5.2 Verification strategy for the integration test

The verification strategy that is proposed for the integration test relies on capabilities of the SystemVerilog language that are lacking in a reference integration test bench of the Danfoss FPGA team. The existing integration test bench is modeled entirely in VHDL and therefore lacks features that are available in HVLs such as SystemVerilog. HVLs often include features from high-level programming languages that are practical for instance when modeling the high-level abstraction equivalent of the DUT in the test bench. Such features are generally not synthesizable in hardware but are functional in simulation.

A review was made of the existing test bench in order to establish what improvements could be made in system level testing. However, before these items are listed, it is important to specify the objectives of testing at this layer. As has been previously stated in this thesis, the testing follows a bottom-up order where IPs are extensively tested before integration tests are performed. The main priorities of the integration tests are therefore to ensure that added features work as intended in the system wide design and that no existing features were broken. As such, there is no need to design tests on this layer that extensively gather coverage. Because of this limitation it was decided that the case study of Chapter 5.2 would be implemented without using functional coverage. An added reason for this decision was that functional coverage would require a license for an advanced simulator with an expensive license. The deficiencies that were identified with the existing VHDL test bench are listed in the following paragraphs.

The first observation is the structure of the test bench. Each time a new feature is introduced to the SUT at least one new test case needs to be introduced to the system level test bench. Understandably the test bench will continue to grow, and consequentially maintenance of the test bench will become more time-consuming. Modularizing the test bench will not decrease the amount of code, but it will increase its readability. SystemVerilog supports classes and OOP and can therefore offer a better solution for modularization than VHDL. The objective of the modularization is to split source code into files that represent a similar class-based architecture than the one presented in Figure 1. In VHDL classes and OOP are not supported. The goal of the modularization is to simplify the continuous maintenance of the system level test bench, and to increase the readability of the code.

The second observation is the stimulus process. In the existing test bench stimulus is written sequentially. This is a problem for functionalities that require parallel stimulus. If, for example, an IP performs priority-based arbitration for multiple data channels, but transactions can only be sent to one channel at a time, the functionality of the IP will remain untested. Multiple processes can of course be modeled in VHDL, and in this case, each of these processes would call a procedure that writes to a specified channel. However, what is argued here is that when there is a significant amount of DUT functionalities that require parallel stimulus, the implementation of a test bench with a class-based architecture is easier to synchronize and maintain. In a class based SystemVerilog test bench, for example, an object is first created for a test class, which in turn creates objects that start the stimulus writing activities for multiple interfaces. A designer not

familiar to the test bench, but familiar to a generic class-based test bench architecture, should be able to identify the functionality of the test bench by inspecting the test class.

The third observation is the monitoring and self-checking of response. As already mentioned in the first paragraph of this chapter, SystemVerilog offers high-level programming features that are practical for modeling the predictor of the DUT. Additionally, if the DUT behavior requires clock cycle accurate checking, SystemVerilog offers concurrent assertions. In VHDL assertions are all immediate.

The fourth and final observation is that the integration test lacks the communication between the processor and the FPGA. In the existing test bench the processors have been excluded as they are either not portable to the simulators, or there are no methods for writing stimulus from them or receiving it. In the context of testing, the most important part of the processor is the AXI bus. To include the AXI communication in the simulation, Bus Functional Models (BFM) are available that simulate the communication between the processor and the FPGA. The BFMs will also be referred to as Verification Intellectual Property (VIP) throughout the following chapters. The BFMs act similarly to agents in any SystemVerilog or UVM test bench and can be used either to initiate communication, in master mode, or to react on communication, in slave mode. As SystemVerilog is a hardware verification industry trend, BFMs are also well available for the language. The ability to spawn multiple threads in SystemVerilog is also a functionality that is well suited to the use of BFMs.

The inclusion of AXI BFMs is also an interesting aspect as it covers an area of testing that has previously been left out of the integration test. In Chapter 4.1 the release test was briefly mentioned, and although it was not chosen as a topic for this thesis, it might perhaps be possible to combine the two separate tests into one. For the FPGA team it would mean that testing would only have to be performed in two phases instead of three.

5.3 Functional coverage

Of the three proposed verification strategies, only the IP level tests would utilize functional coverage. However, as it is proposed that the full IP test bench consists of multiple test cases that are directed at certain DUT requirements, the functional coverage can be somewhat less specified for the full IP test bench than for the divide and conquer method. For example, if the full IP test bench contains a test case that writes a protocol error transaction to the DUT, there is no need to write a functional coverage item for this event. The divide and conquer method, on the other hand, is a single randomized test case and would therefore require that a functional coverage item is implemented that checks all transactions for protocol violations. Another example could be a buffer overflow condition. With the full IP test bench a buffer overflow would likely be tested with a directed test case for which a transaction sequence ensures that the overflow occurs. The divide and conquer method, in contrast, would likely have access to a peripheral signal of the DUT that signals an active overflow. For the latter a functional coverage item corresponding to this DUT signal would be included in the coverage collector.

Although the functional coverage for the two proposed methods differ, there should be a minimum requirement for what is sufficient testing. The design requirements must of course be validated, but corner cases for each user register should also be tested. A user register corner case could be, for example, the assertion and deassertion of a single bit that enables or disables a DUT feature. Other corner cases could be the maximum and minimum values for a configuration that has a range wider than one bit. An example of functional coverage used in the case studies will be provided in Chapter 7.1. The functional coverage of the full IP test bench will consist of checkers for the user register configurations. The divide and conquer test bench will additionally contain coverage checkers to assure that certain events have occurred during testing.

6 CASE STUDIES

In this Chapter case studies related to the IP-block level testing and integration testing are presented. For the IP-block level testing the DUT that was chosen is a Discrete Root Mean Square (DRMS) and Spectrum Analyser (SA) co-processing IP. The DRMS and SA co-processing IP was tested with the full IP test bench method and the divide and conquer method. For the integration test the case that was chosen is a priority encoded communication between two FPGA nodes. The SUT consists of multiple IPs that implement a full-duplex communication. As both of the FPGA nodes contain an embedded processor, the case study also describes how the interface between the processor and the FPGA is included in simulation. The DRMS module will also be referred to simply as the Root Mean Square (RMS) module throughout this thesis.

6.1 Testing the Discrete Root Mean Square and Spectrum Analyser co-processing IP

In this chapter the functional description of the DUT will be given and the methods of the two separate case studies for the IP-block level testing will be presented. Both case studies rely on CRV and UVM. The results of the case studies will be presented in Chapter 7 and the implementation methods will further be discussed in Chapter 8.

6.1.1 Functional description of the IP

The DRMS and SA co-processing IP implements parts of the DRMS and the Goertzel algorithm. The IP is used in conjunction with software, which configures the IP and reads the results from it. The DRMS and SA calculations are independent of each other, and although the user registers are common for the modules, they can be used concurrently or separately. The bit fields inside the user registers are separate for the modules and therefore each of the two can be configured without affecting the other. Formula 1 describes the complete DRMS calculation while Formula 2 is the actual calculation that is performed in the co-processing IP.

$$I_{RMS} = \sqrt{\frac{1}{n}(I_1^2 + I_2^2 + \dots + I_n^2)}$$
(1)

$$I_{TOT} = I_1^2 + I_2^2 + \dots + I_n^2$$
(2)

The result of Formula 2 is stored into user registers that are read by the software. The software handles the division and square root of Formula 1 upon reading the registers. The SA is described by the following pseudocode. The part that is implemented in the IP has been highlighted by a bolded font.

```
ω = 2 * π * K / N;
cr = cos(ω);
ci = sin(ω);
coeff = 2 * cr;
z_1 = 0;
z_2 = 0;
for each index n in range 0 to N-1
  z_0 = x[n] + coeff * z_1- z_2;
  z_2= z_1;
  z_1= z;
end
p = z 2* z 2+ z 1* z 1- coeff * z 1* z 2;
```

In the pseudocode above the input to the IP is denoted by x[n]. The input is a current sample that has been measured by another IP. The coefficient coeff is written to the IP by the software prior to a computation. The outputs of the algorithm z_0 , z_1 and z_2 are stored to user registers that the software reads after a finalized computation. The power density p is then calculated with the values that were read. A block diagram representation of the DRMS and SA co-processing IP is given in Figure 10. The block diagram illustrates the inputs to the IP-block and the internal signals of the IP that are of interest for the verification of the IP. The IP-block interacts with three interfaces – the Memory Mapped User Register (MMUR) interface and two Analog to Digital (AD) measurement channels. The AD-measurement channels will be referred to as the *Idc* channel and the *Icm* channel.

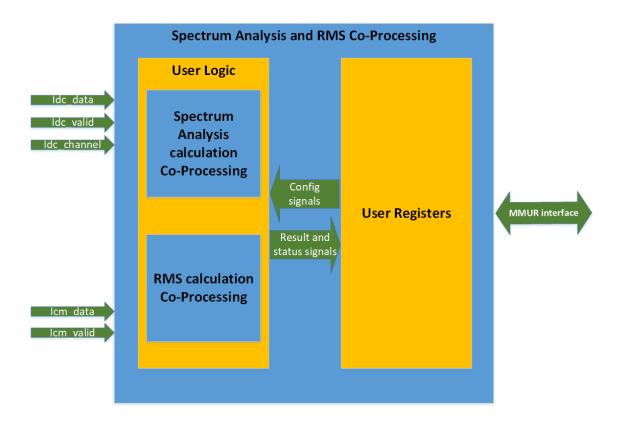


Figure 10. A block diagram representation of the DRMS and SA Co-Processing IP. The IP-block is configured through the MMUR interface, which is also used for reading status information and the results from the IP. Each of the co-processing modules calculate the result for either a set of Icm or Idc measurement samples. The input channel for any given calculation depends on the multiplexing configurations that have been written to the IP-block.

6.1.2 The verification plan

A verification plan was made for the DRMS and SA co-processing IP prior to building the test bench. The purpose of the verification plan is to identify requirements of the design and to identify the functionalities that have to be tested. The verification plan also contains a block diagram of the UVM test bench that represents the classes. The block diagram is shown in Figure 10. The verification plan was made for the full IP test bench, as it was designed before the divide and conquer test benches. Nevertheless, the design requirements that have been specified in the verification plan are valid for either testing method and were therefore used for the functional coverage of either one. The design requirements are listed in Table 2.

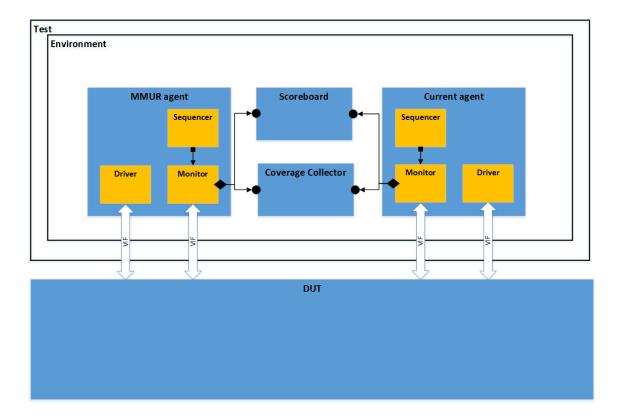


Figure 11. Block diagram of the test bench for the DRMS and SA co-processing IP. The environment contains two agents: the MMUR Agent and the Current Agent. There is also a class for gathering functional coverage, the Coverage Collector, and a Scoreboard. In this test bench the predictor has been included in the Scoreboard.

Function	Requirement
Calculation output	The output data of the DRMS and SA mod- ules should conform to their respective ref- erence models. The reference model for the DRMS is formula 2 and for the SA the bolded pseudocode presented in this chap- ter.
Input Multiplexing	Only one input current channel can be sam- pled by the DRMS or SA calculation during one computation window. If both modules are simultaneously active they can sample the same current channel or different current channels.
Downsampling	All downsampling factors in the specified downsampling range must be functional. Downsampling factor 0 should be treated as 1.
IP Disabled and Reset	The Enable IP signal resets the datapath signals. Disabling the IP should only clear the result registers and not affect the configurations. The Reset signal resets the datapath signals and the configurations.
Overflow	The bit widths of the design should ensure that overflow can never occur.
Computation Configurations	The configurations for the input multiplex- ing, downsampling, calculation window size and Goertzel algorithm coefficient (SA only) should never change during an active computation window. The configurations should be latched when a computation win- dow is started.
Debug Feature	The DRMS and SA modules can both use a debug feature mode where a value is written to a user register prior to a computation. The debug data should be readable from a user register and multiplexed as input instead of any of the two current channels.
Concurrency	The DRMS and SA should operate inde- pendently of each other. There should be no effect on either one of the functionalities if they are simultaneously active.

Table 2. Design requirements for both the DRMS and SA co-processing modules.

6.1.3 The full IP test bench

Before building the classes of the UVM test bench the architecture of the test bench was planned. The first action was to identify interfaces of coherent signals in the DUT. Three interfaces were identified, as already described in Chapter 6.1.1. However, for this case study both of the AD-measurement channels were combined to one agent – the Current agent. The second agent of the test bench is the MMUR agent, which is used for writing and reading to and from the user registers of the IP-block. The Current agent drives samples from two separate measuring systems to the DUT in real hardware, and could therefore also have been split into two agents. The amount of signals per current interface, two for the Icm channel and three for the Idc channel, was however the reason for combining the two interfaces into one agent. Figure 11 also shows that for this test bench it was decided that the predictor model would reside inside the scoreboard.

Before implementing any classes, the requirements for the self-checking of the test bench were determined. The scoreboard in this case is based on the In-Order Array Scoreboard that was presented in Chapter 3.1.4. The In-Order type is preferred as the IP always returns a response for one computation before another can be started. The In-Order scoreboard furthermore requires the array as the results of both co-processing calculations are split and stored in multiple registers of the IP. For this reason the predictor model must also make multiple predictions per calculation. The implementation of this case study does however differ slightly from the representation of Figure 4. Because the full IP test bench requires that user registers containing the calculation results are polled, the getkey()-function was excluded. The function is of no use in this case as the register that is read is known and can directly be matched with the corresponding prediction in the scoreboard.

6.1.4 Test cases of the full IP test bench

Before starting to build the test bench, test cases that validate the requirements of Table 2 were planned. The test cases, which will be described in the following paragraphs, were all applicable to both co-processing modules. A user register write and read test

case was omitted in this case study as it had already been done for the IP with another test bench.

A *base test* was implemented for both the DRMS and SA that follows the recommended instructions for using either of the co-processing modules. In the base test the input multiplexing, downsampling factor, calculation window size and Goertzel algorithm coefficient (SA only) are all configured, after which a computation window is started by toggling a start-bit in a control register. A status register is then polled that contains a bit to signify a completed computation. The results are then read from the user registers and compared to the predicted results.

A *reset test* was implemented to test the DUT when the reset signal is asserted at a random time during a computation. The result registers are read after the reset and once again after an invalid computation that hasn't received new configurations has been started. The latter computation should confirm that no configurations have been stored in the user registers.

An *IP disabling test* was implemented to test the DUT when the IP is disabled at a random time during a computation. The result registers are read after the IP is disabled. The IP disabling sequence is followed by a normal computation window to confirm that the DUT has recovered as expected.

The *overflow test* is intended to test that neither the DRMS or SA result registers overflow when worst case data is driven to either module. For the DRMS the worst case scenario is when the maximum calculation window size is used and all current samples have the value -2^{15} . The value corresponds to the maximum negative value in the two's complement range for 16-bit signed values. For the SA the worst case scenario is achieved when a maximal amplitude sine wave in the passband of the Goertzel algorithm is driven to the DUT. For the Goertzel algorithm the passband equals the frequency bin that is analyzed, and it is dependent on the coefficient. The *reconfiguration test* tests that the latching of computation window configurations works as intended. The reconfiguration test randomly writes changed configurations to the DUT once a computation window is already active. The DUT should ignore these configurations.

The debug feature is tested with a *debug data test*. The test is identical to the base test with the exception that the input multiplexers are configured to route the debug channel into the DUT.

The final test that was implemented is a *concurrency test* where each of the coprocessing modules are simultaneously active. The test validates that the co-processing modules can be used in parallel, either by starting the computation windows at the same time or at separate times. The test also covers the case in which both co-processing modules complete their computations at the same clock cycle.

Constrained randomization has been used in the tests for the DUT configurations, while a simpler uniform randomization has been used for randomizing the time at which reconfiguration or disabling of the IP occurs. While all of the test cases are directed at a design requirement, they all gather code coverage and functional coverage that is common and eventually merged. Because of the randomization the tests can be called multiple times to raise coverage. Each test also has an arbitrary iteration count that can be modified by the user. For instance, if high coverages are desired, a test could be assigned a high iteration count and be run outside working hours.

6.1.5 Building the full IP test bench

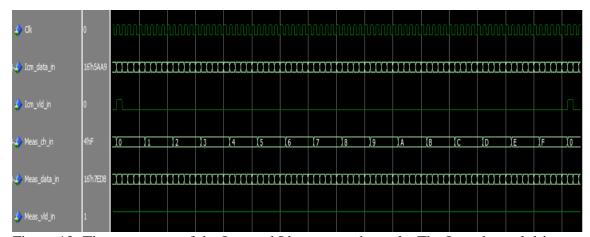
The designing phase of the test bench followed much of the same bottom-up order that was introduced in Chapter 3.1.3. The classes seen in Figure 11 are described in the following paragraphs. Code segments have also been provided to give an insight of how the functionality of each class has been implemented. The *agent* and *environment* classes have been excluded as they merely connect classes to each other.

The first classes that were designed were the sequence items. To understand how to build the sequence item, however, the designer should first determine what sequences the agent should drive. For the MMUR interface there is a write sequence, a read sequence and an idle sequence. The sequences are of variable length in terms of clock cycles, but do not differ much in signal activity. In fact, it was determined that one sequence item could be used to build all sequences. The *write enable* and *read enable* signals of the sequence item are assigned fixed values upon being created in the sequence. The read sequence, for example, consists of three sequence items – one sequence item with an asserted read enable signal followed by two sequence items with both write enable and read enable deasserted. The idle time of the sequence assures that the DUT has enough time to handle the read request. The same functionality could also have been implemented by the driver with a handshake task that waits for an *acknowledge* input from the DUT to be asserted.

In the current agent the sequence models the behavior of the current measurement interfaces between the DUT and the Analog to Digital Converters (ADC). In the DUT of this case study there are two separate current measurement interfaces. Both interfaces contain two similar signals – a 16-bit signed type bit vector representing data and a one-bit signal representing valid data. In addition, the Idc interface contains a signal that represents the AD-channel that the sample was measured from. Consequentially, the sequences of the two interfaces differ. The code segment below represents the task that drives a sequence for the two current interfaces. In this example the signals of the Idc interface have a prefix of Meas .

```
//Omit class definition, constructor and irrelevant
//variables from this example
bit [3:0] channel;
int meas_ch_counter;
//For sampling frequency of 1.25 MHz when system clock
//is 100MHz: 100 MHz/1.25 MHz = 80.
const int Fs_period = 80;
//16 channels in the ADC of the Idc channel
const int Num_channel = 16;
task body();
```

```
Current transaction tx;
  channel = 0;
  meas ch counter = 0;
  for(int i=0; i<Fs period; i++)</pre>
  begin
   if(i == 0)
    begin
      //Icm vld in asserted, Meas vld in asserted
      tx = Current transaction
        ::type_id::create(.name("tx "),
        .contxt(get full name()));
      start item(tx);
      assert(tx.randomize() with {
        Meas vld in == 1;
        Meas ch in == channel;
        Icm vld in == 1;}
      );
      finish item(tx);
    end
    else
    begin
      //Icm vld in deasserted, Meas vld in asserted
      tx = \overline{Current} transaction
        ::type id::create(.name("tx"),
        .contxt(get full name()));
      start item(tx);
      assert(tx.randomize() with {
        Meas_vld_in == 1;
        Meas ch in == channel;
        Icm vld in == 0;}
      );
      finish item(tx);
    end
    //Create Idc channel switching frequency of
    //Fs period/Num channel clock cycles
    if (meas ch counter == Fs period/Num channel-1)
    begin
      meas ch counter = 0;
      if(channel== 15)
        channel= 0;
      else
        channel++;
    end
    else
    begin
      meas ch counter++;
    end
  end
endtask: body
```



The preceding code segment creates the sequences that can be seen in Figure 12.

Figure 12. The sequences of the Icm and Idc current channels. The Icm channel drives a valid sample at a frequency of 1.25 MHz. For the Idc channel the valid-signal stays asserted and a channel switching frequency of 78.125 kHz switches the sampling channel. The sampling frequency for all Idc channels is therefore also 1.25 MHz. The DUT stores the first Idc sample it detects after a channel switch and ignores other samples.

As there are no handshake requirements for either agent in this design, the drivers for both agents are simple. In fact, both agents can share one driver implementation with the only difference being the signals that are driven. The following code segment represents the task inside the driver of the current agent.

```
task drive();
Current_transaction tx;
forever begin
   //Fetch the transaction from the sequencer
   seq_item_port.get_next_item(tx);
   vif.length = tx.length;
   vif.delay = tx.delay;
   //Initial delay before driving transaction
   repeat(tx.delay)
   @(posedge vif.Clk);
   //Drive transaction
   repeat(tx.length)begin
   @(posedge vif.Clk)
    vif.Meas_data_in <= tx.Meas_data_in;
    vif.Meas_ch in <= tx.Meas_ch in;</pre>
```

```
vif.Meas_vld_in <= tx.Meas_vld_in;
vif.Icm_data_in <= tx.Icm_data_in;
vif.Icm_vld_in <= tx.Icm_vld_in;
end
//End transaction after tx.length clock cycles
seq_item_port.item_done();
end
endtask: drive
```

In the code segment above the length and delay variables have been added to the driver to add flexibility. The delay variable can be used to insert an initial delay before the transaction is driven. The length variable can be used to drive the transaction for multiple clock cycles. Both of these are optional and can be constrained in the sequence item to 0 and 1 respectively.

The next classes to be implemented were the monitors. Although the block diagram of figure 10 only contains one monitor per agent, two monitors were actually implemented for the MMUR agent. The MMUR agent contains one monitor that monitors transactions when write enable or read enable are asserted and another that monitors transactions when a read acknowledge signal is high. The aforementioned monitor writes to both the coverage collector and the predictor in the scoreboard. The latter monitor writes the actual DUT response to the scoreboard when the result registers are read. The current agent only contains a monitor that writes to the coverage collector and the predictor. As there are two current interfaces there are also two monitoring threads that are executed in a task. The threads trigger a write to the coverage collector and scoreboard when their respective monitoring events occur. The two code segments below are, in order, the run_phase task of the reading side MMUR monitor and the run_phase task of the current monitor.

```
task run_phase(uvm_phase phase);
MMUR_transaction tx;
tx = MMUR_transaction
    ::type_id
    ::create(.name("tx"),
    .contxt(get_full_name())
);
```

```
forever begin
  @(posedge vif.Clk)
  begin
    if(vif.Mmur_re_ack_out == 1'b1)
    begin
        //Assign signals from virtual interface
        //to the transaction tx
        tx.Mmur_addr_in = vif.Mmur_addr_in;
        //...
        //Send the transaction to the analysis port
        mon_ap_read.write(tx);
        end
        end
```

In the above excerpt the monitoring event occurs when the read acknowledge signal is asserted. The mon_ap_read.write(tx) statement writes the monitored event to the analysis port that in turn forwards the transaction to the scoreboard.

```
task run phase(uvm phase phase);
 tx Idc = Current transaction
    ::type id
    ::create(.name("tx Idc"),
    .contxt(get full name())
 );
 tx Icm = Current transaction
    ::type id
    ::create(.name("tx Icm"),
    .contxt(get full name())
 );
 int prev ch;
 fork
 begin
    //Monitoring thread for Idc
    forever
   begin
      @(posedge vif.Clk)
  if (vif.Meas vld in==1'b1&& (prev ch!=vif.Meas ch in))
      begin
        //Delay for one clock cycle and sample data
        @(posedge vif.Clk)
```

```
tx Idc.Meas data in = vif.Meas data in;
        tx Idc.Meas ch in = vif.Meas ch in;
        //Send the transaction to the analysis port
        mon ap Idc.write(tx Idc);
      end
      prev ch = vif.Meas ch in;
    end
 end
 begin
    //Monitoring thread for Icm
    forever
    begin
      @(posedge vif.Clk)
      if(vif.Icm vld in == 1'b1)
     begin
        //Delay for one clock cycle and sample data
        @(posedge vif.Clk)
        tx Icm.Icm data in = vif.Icm data in;
        //Send the transaction to the analysis port
        mon ap Icm.write(tx Icm);
      end
    end
 end
 join
endtask: run phase
```

In the above excerpt two separate monitoring events occur in separate threads. The Idc interface triggers a monitoring event when the valid-signal is asserted and a channel switch occurs. For the Icm interface the trigger is the asserted valid-signal.

The coverage collector receives monitored transactions from a total of three streams. As much of the DUT functionality is based on the configurations in the user registers of the IP, the functional coverage of the DUT is based on the monitored transactions from the MMUR agent. Register configurations that have been written to the DUT are covered by cross-coverage items that cross multiple cover points. The required cover points are the *write enable* signal, which must be asserted, the *address* signal and the *data* signal. The code segment below illustrates how coverage collection is implemented for the downsampling factor configuration of the DRMS module.

```
cp DOWNSAMPLING RMS data:
    coverpoint tx MMUR.Mmur w data in[4:0]
      //bins for the whole downsampling range
      //all bins must be covered
      bins corner min = \{0\};
      bins corner 1 = \{1\};
                     = { [2:29] };
      bins data
      bins corner 29 = \{30\};
      bins corner max = \{31\};
    }
  cp Mmur we in:
    coverpoint tx MMUR.Mmur we in
      //only the TRUE-value of the write-enable signal
      bins TRUE = \{1\};
    }
  cp Mmur addr in:
    coverpoint tx MMUR.Mmur addr in
    ł
      //bins for all enumerated type values
      //corresponding to user register addresses
      bins DOWNSAMPLING FACTOR REG =
            {DOWNSAMPLING FACTOR};
      bins INPUT SELECT R\overline{E}G =
            \{INPUT SELECT\};
      bins CALC WINDOW SIZE REG =
            {CALC WINDOW SIZE};
      bins SPECTRUM ANALYSIS COEFF =
            {SPECTRUM ANALYSIS COEFF};
  }
Downsampling RMS cross:
cross
  //this cross-coverage item crosses the following
  //three coverpoints
 cp DOWNSAMPLING RMS data,
 cp Mmur addr in,
  cp Mmur we in
    {
    //cross-coverage that covers the minimum
    //downsampling factor of the RMS calculation
    bins RMS cross min =
      binsof(cp DOWNSAMPLING RMS data.corner min) &&
      binsof(cp Mmur addr in.DOWNSAMPLING FACTOR REG) &&
      binsof(cp Mmur we in.TRUE);
    }
```

In the above code three cover points are defined and a cross-coverage item is created for downsampling factor 0. The cross-coverage item covers data that is written to the enumerated type address DOWNSAMPLING_FACTOR_REG.

The final class to be implemented inside the environment was the scoreboard. As the predictor model was built inside the scoreboard, the scoreboard was also the class that required most time and effort during the design phase. The predictor model is updated by four concurrent threads that call tasks that execute in an endless loop. One task samples the MMUR agent, two tasks sample the current interfaces of the current agent and a fourth task samples the reset-signal. The three first mentioned tasks block their program flow until transaction items are received from their corresponding monitors. The reset sampling task, on the other hand, samples the reset-signal on each clock cycle. Common for all of these tasks is that they call a function or another task whenever an activity occurs. If the activity that occurs results in an immediate event a function can be called. If, however, the activity results in a time-consuming event, a task containing clock synchronization must be called. In this case a new thread must be spawned for the clock synchronized task. The new thread should perform the time-consuming event while the sampling task returns to sampling new activity. An example of this is given below. The example illustrates how an active reset can be handled by the predictor model.

```
task run();
    fork
      //Threads 1-3 left out from this example
      //Thread 4
      begin
        sample reset();
      end
    join
endtask: run
task sample reset();
    forever
    begin
      @(posedge vif.Clk)
      begin
        if (vif.Rst)
          reset all();
      end
    end
endtask: sample reset
task reset all();
    fork
    begin
      @(posedge vif.Clk)
```

```
begin
    //Assign default reset values here
    end
    end
    join_none
endtask: reset_all
```

The above tasks demonstrate how the clock synchronized reset can be implemented in the predictor. In this example the reset delay for the signals in the reset_all task would be one clock cycle. The thread that calls the task returns immediately to sampling the reset as fork...join none is used for creating a separate thread.

The tasks for predicting the DRMS and SA computations are called each time a valid current sample is received from a current monitor. There are three tasks to perform the prediction. The Idc, Icm and debug data all have one predictor task which at any time can be active for either the DRMS or the SA. The calculation window size that is latched when a computation starts determines the total amount of samples for one prediction. The downsampling factor, also latched when a computation starts, specifies which of the received current samples are included in the calculation. The input select is used to either enable or disable a predictor task. A maximum of two tasks can be active at any time. The code segment below demonstrates the DRMS and SA predictor task for the Idc channel.

```
task write to reference Idc();
  //sample channel 7 of Idc current
  //if the sample count is smaller than
  //the configured calculation window
 if (Input select RMS == 0 && tx Idc.Meas ch in == 7
     && counter Idc RMS < Calc window size RMS)
 begin
      @(posedge vif.Clk)
     begin
        //perform downsampling
        if (counter Idc downsampling RMS >=
           Downsampling RMS)
       begin
          //update RMS result if sample was valid
          RMS result =
          RMS result + tx Idc.Meas data in**2;
          counter Idc RMS++;
          counter Idc downsampling RMS = 1;
        end
```

```
else
          //increment downsampling counter
          counter Idc downsampling RMS ++;
      end
  end
  //sample channel 7 of Idc current
  //if the sample count is smaller than
  //the configured calculation window
  if (Input select SA == 0 && tx Idc.Meas ch in == 7
     && counter Idc SA < Calc window size S\overline{A} )
  begin
      @(posedge vif.Clk)
      begin
        //perform downsampling
        if(counter Idc downsampling SA >=
            Downsampling SA)
        begin
          //perform Goertzel algorithm
          //calculations and update
          //results for ZO, Z1 and Z2
          Spectr coeff x Z1 = Spectr coeff * Z1;
          Z0 pre shift = tx Idc.Meas data in +
           (Spectr coeff x \overline{Z}1 >> 16) - Z2;
          //shift Z0 pre shift by 4
          ZO = (ZO \text{ pre shift} >> \overline{4});
          Z2 = Z1;
          Z1 = Z0;
          counter Idc SA++;
          counter Idc downsampling SA = 1;
        end
        else
          //increment downsampling counter
          counter Idc downsampling SA ++;
      end
  end
endtask: write to reference Idc
```

While the DRMS reference implements the algorithm of Formula 2, the SA reference is a modified version of the highlighted pseudocode in Chapter 6.1.1. For the SA reference bit shifting has been inserted at intermediate steps of the calculation to avoid overflow in the design. The shift operations are denoted by the >> sign in the code above. As the relevant ADC-channel was channel 7, it is also seen in the conditional statement that precedes each predictor calculation.

6.1.6 Building the divide and conquer test benches

The main interest of the divide and conquer method was to determine whether a fully randomized test could be made with a reasonable design effort. As stated previously, the full randomization in this context would mean a single test case in which the sequence of events is randomized. A fully randomized test case minimizes the amount of time required for writing test cases and can be adjusted by modifying the constraints of the sequences. A fully randomized test should also be able to reveal corner cases not considered by the designer of the test bench. The divide and conquer method of this case study was performed after the full IP test bench case study had been completed.

During the design phase of the full IP test bench it was identified that a full randomization would require additional functionality in some of the test bench classes, namely for reset awareness. Other changes that would be beneficial for the test bench structure were also observed, such as creating an agent for the reset signal, splitting the Idc and Icm interfaces into two agents and creating predictors for the DRMS and SA modules in classes outside the scoreboard. It was also decided that clock synchronization would be excluded from the predictors and instead implemented at a lower level in the monitors. The case study of the divide and conquer method has been implemented for the user logic test bench as it was deemed to be adequate for demonstrating a fully randomized test. The following paragraphs will detail the added functionalities that are required by a fully randomized test bench. The block diagram of the test bench is depicted in Figure 13. Figure 14 shows the connections to the classes outside of the agents that reside in the environment: the RMS predictor, the SA predictor, the coverage collector and the scoreboard.

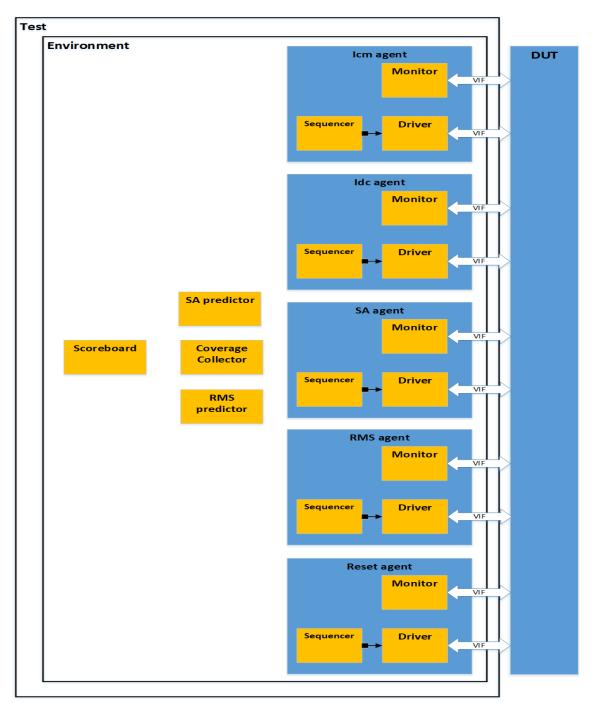


Figure 13. Block diagram for the user logic test bench of the DRMS and SA coprocessing IP. In this figure the analysis ports from the monitors to the four classes in the environment have been left out for the sake of clarity. The connections to these four classes have been illustrated in Figure 14. As in Figure 11, some monitors have been depicted as one block although two monitor classes have been designed in the agent. The agents with two monitors are the RMS agent and the SA agent.

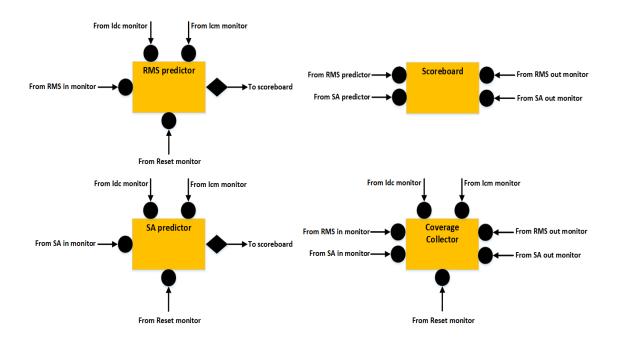


Figure 14. The connections to the four classes outside of the agents in the block diagram of Figure 13. A black circle represents an analysis export that receives transactions from an analysis port of either a monitor or a predictor. A black diamond represents an analysis port.

As can be seen in Figure 13, five agents are present in the test bench. The Icm and Idc currents can be driven individually of each other in contrast to the previously implemented full IP test bench. The reset agent has also been created to offer more flexibility over signals that drive a reset. For the DRMS and SA co-processing IP there is a *reset* signal but also an *enable_IP* signal with the same effect. These two signals are driven by the reset agent and their occurrence is controlled by constraints. However, apart from the normal sequence with randomized reset occurrence, there is also an initial reset sequence that holds the reset active at the beginning of the test. The fully randomized test is achieved by creating five threads that start the sequences – the ones seen in the waveform of Figure 12. For the other agents the sequences that are driven are simply randomized sequence items. The initial reset sequence, at a length of 10 clock cycles, is also just one sequence item with the *length* variable constrained to 10.

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In the divide and conquer case study more design effort was put into the monitors of the agents. The objective was to create monitors that would allow clock synchronization to be excluded from the predictors. By doing so the classes outside of the agents would all be modeled on the transaction level, which would arguably be easier to comprehend for an engineer not familiar with the specific timing of the DUT. In the full IP test bench the reset awareness of the test bench has been implemented in the predictor model of the scoreboard. In this case study the same functionality has been moved to the monitors. An example of this is given in the following code segment from the RMS output monitor. In the code segment the analysis port corresponding to the DUT response can be written to only when the reset is deasserted. A task inside the RMS output monitor continuously monitors the state of the reset signal. An active reset will nullify a calculation event in the DUT and therefore it is not desired that a DUT response is written to the scoreboard when the reset is asserted. In the predictor the predicted response for the same calculation event will similarly be cleared once the monitor of the reset agent signals that the reset is asserted.

```
task run phase(uvm phase phase);
    RMS transaction tx;
    tx = RMS transaction
     ::type id
     ::create(.name("tx"),
     .contxt(get full name())
    );
fork
 begin
    forever
    begin
      @(posedge vif.Clk)
      begin
        if (vif.Rms done out &&
           Rms done out prev != vif.Rms done out &&
           !reset asserted && Rms calc size > 0)
        begin
      //Monitor signals that are received from the DUT
            tx.Rms result msb out
            = vif.Rms result msb out;
            tx.Rms result lsb out
            = vif. Rms_result lsb out;
            //Send the transaction to the analysis port
            mon ap out.write(tx);
        end
```

```
//Edge detection for 'done out' signal
      //Only write to analysis port on rising edge
      Rms done out prev = vif.Rms done out;
    end
  end
end
begin
  forever
  begin
    @(posedge vif.Clk)
    begin
      fork
        //Call task that monitors reset
        //and enable IP signal
        //Reset is asserted/deasserted
        //with a latency of 3 clock cycles
        assert reset();
      join none
    end
  end
end
join any
endtask: run phase
```

In this case study the predictors for the DRMS and SA modules were created as separate classes outside the scoreboard. The reason behind this decision was modularity. During the full IP test bench case study it was observed that the amount of code in the scoreboard grew significantly when the predictors of both the DRMS and SA modules were implemented inside the scoreboard class. In addition, the purpose of the tasks and functions inside the scoreboard were not trivial – tasks and functions for both prediction and comparison were written inside the same class. In this case study the scoreboard only does the comparison and keeps track of the amount of successful and erroneous comparisons. The comparisons have been implemented as in Figure 3 and they are triggered when either the RMS out or SA out monitors send a transaction to the scoreboard.

As stated in Chapter 5.3, fully randomized tests require functional coverage items for events that must be tested. As one calculation window for either the DRMS or SA coprocessing may last for as much as 20 ms, the probability for an asserted *reset* or deasserted *enable_IP* has been set to 1 in 10000000 sequence items. This probability was chosen once it was discovered that higher probabilities caused too many interrupts, especially for calculation events with longer calculation windows. However, at this prob-

ability the time before a reset occurs may be as much as several hours of simulation, and there is no guarantee that such event occurs for one iteration of the test. Functional coverage items are therefore written to ensure that resets have been tested when a calculation is active for the DRMS or the SA module, but also when either of the modules are idle. The method for implementing such coverage is cross-coverage. In this case two cross-coverage items were created - one for the reset signal and another for the enable_IP signal. The cover points for these signals are crossed with two local variables in the coverage collector that signify whether a calculation is active or not in the DRMS or the SA module. The calculation_active_RMS and calculation_active_SA variables are set to true whenever a transaction signaling a starting calculation is received from the RMS_in or SA_in analysis exports depicted in Figure 14. Conversely, the variables are set to false whenever a transaction signaling a completed calculation is received from the RMS_out or SA_out analysis exports. The variables are also set to false if a transaction is received from the *Reset* analysis export. The reset functionality of the DUT can be considered fully tested only when the functional coverage for the reset and enable_IP cross-coverage items is 100%.

6.2 Testing the priority arbitrated full-duplex communication SUT

The case study of the system wide test is implemented as a SystemVerilog test bench for which randomization and the utilization of UVM has been excluded. As mentioned in Chapter 5.2, the communication with the embedded processors of two separate FPGA nodes has been modeled with AXI BFMs provided by FPGA manufacturer Xilinx. In order to simulate a system wide FPGA design, the embedded processors of the design are removed from the system and replaced by BFMs. The amount of BFMs and their type depend on the processors. In the SUT of this case study three types of AXI BFMs are used: the AXI4-Lite BFM, the AXI4-Stream BFM and the AXI3 BFM. The BFMs are provided as agents and are similar in structure to the UVM agent described in Chapter 2.1.3. Although UVM is not used in this case study, the objective is to create a test bench that benefits from a test bench architecture that is common for object-oriented SystemVerilog. Although SystemVerilog assertions have not been implemented in this case study, their potential use for this test bench will be discussed in Chapter 8.

6.2.1 Functional description of the SUT

The SUT of this case study, depicted in Figure 15, consists of multiple IPs that create a communication between two embedded processors on separate FPGA nodes. The communication through the FPGA has been designed for two communication protocols, of which one is of higher priority. Although there are in total seven AXI BFMs of various types in use in this case study, the AXI communication represented in Figure 14 only amounts to five of these. The two remaining BFMs are node-specific AXI BFMs used solely for configuring the IPs.

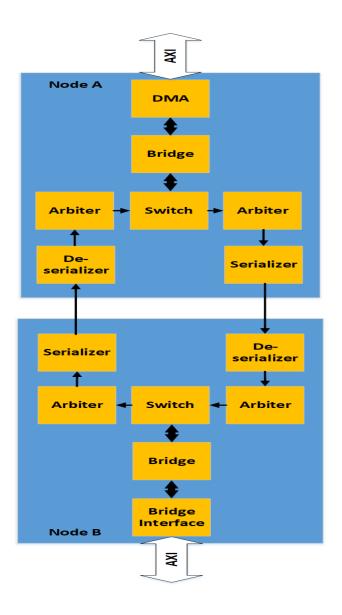


Figure 15. The SUT of the integration test case study. Two FPGA nodes, here represented as the blue blocks, contain a set of IPs that create a full-duplex communication between two embedded processors. The processors, which have been excluded from the figure, communicate with the Direct Memory Access (DMA) of Node A and the Bridge Interface of Node B. The communication between the IPs and the embedded processors is performed through AXI-protocols. In addition, although it has not been depicted in this figure, each IP is configurable through AXI transactions from node-specific AXI configuration channels.

The DMA of the Node A in Figure 15 communicates with an AXI3 BFM that is configured as a slave agent. The DMA, being the master of a master-slave communication between itself and the processor, would in the real design initiate read requests to access the cache of the processor. In the simulation, however, the cache has been modeled by a SystemVerilog associative array that is indexed by the address signal of the AXI transaction. The data is initialized into the array before the simulation is run and it is a task of the driver component of the AXI3 slave agent to respond to read requests with valid data. The DMA is configured by a node-specific AXI4-Lite master agent and contains, among other registers, a register that is written to whenever DMA transmissions are desired. Other IPs inside Node A are configured by the same AXI4-Lite master agent.

The embedded processor of Node B has in this case study been modeled by five separate BFMs. As for Node A, an AXI4-Lite master agent writes configurations to the various IPs inside the node. The actual communication of Node A embedded processor is modeled by four AXI4-Stream BFMs. Two of these are configured as master agents while the other two are configured as slave agents. In contrast to the AXI3 or AXI4 protocols, the dataflow of the AXI4-Stream protocol is unidirectional. Consecutively, the two master agents of Node B transmit data towards the FPGA while the slave agents receive data from it.

6.2.2 The verification plan

As for the IP-block tests, requirements of the design were determined before starting the building phase of the test bench. Performance-related requirements such as throughput or latency of the communication have not been addressed at this verification layer. Instead, such metrics are tested and verified on a higher level that includes the firmware of the device. The requirements of the design that are addressed by the test bench of this case study are listed in Table 4.

Function	Requirement				
	The content of a received message should				
Message validity	match with that of a message that has been				
	sent.				
	The system should be able to transmit or				
Concurrency	receive multiple simultaneously active mes-				
	sages with the same destination.				
Message routing	Messages received at either the DMA of				
	Node A or the Bridge Interface of Node B				
	should be stored in the correct buffer of ei-				
	ther IP. The buffer selection is based or				
	routing configurations that are software				
	configurable.				
	Deadlocks, which for this system could oc-				
Uninterrupted communication	cur as a result of faulty buffer multiplexing,				
	should never occur.				
	If two messages of different priorities are				
Priority arbitration	sent simultaneously, the message with the				
	higher priority should be received at the				
	destination first.				

Table 4. Design requirements for the priority arbitrated full-duplex communication of the SUT.

Out of all requirements listed in Table 4, the priority arbitration is perhaps a requirement that should have been tested on the IP block level. Arbitration is done by the arbiter IP that can be seen in Figure 15, however, a priority multiplexing is also implemented on the Bridge Interface of Node B. These are features that would arguably be easier to test extensively on the IP-block level with constrained randomization and assertions. In a system level test visibility into the SUT is limited, and in addition, the propagation delay through the IPs preceding the arbiter is nondeterministic. Testing the priority arbitration will therefore not be a focus of this case study. For the remaining design requirements, two system level tests were designed – one for transmitting messages from Node A to Node B and another for transmitting messages in the other direction. The requirement of concurrency would of course dictate that a third test should be designed with communication occurring in both directions concurrently. This test was however left out of this case study to limit the workload. Although tests have been implemented for communication in either direction, Node A to Node B and vice versa, only the Node B to Node A test will be described in detail. The second test case relies on the same design principles and its implementation details have therefore been excluded from this thesis. The Node B to Node A test will from here on be referred to simply as the NBNA-test. The other test case will be referred to as the NANB-test.

6.2.3 Building the NBNA-test

To achieve a communication from the embedded processor of Node B to the embedded processor Node A, a test bench with the structure depicted in Figure 16 was built. The various AXI agents inside the test bench block of the figure simulate the processors.

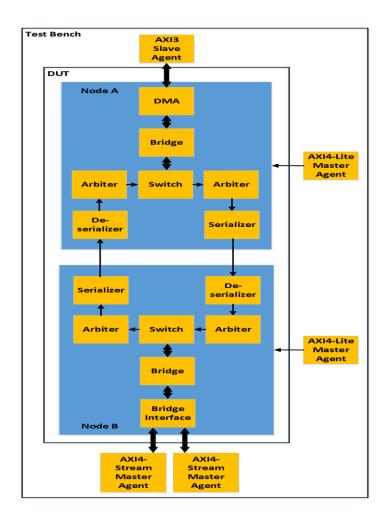


Figure 16. The block diagram depiction of the NBNA test bench. For this test a total of five AXI BFMs are required to model the behavior of the embedded processors. In the NANB-test the only difference in the test bench architecture is in the two AXI4-Stream agents communicating with the Node B, which are instead slave agents.

As in the UVM test benches of the IP-block level tests, the top module of this case study has been made simple. The top module oscillates a clock at 50 MHz and toggles the initial reset. These signals are also connected to the top module of the SUT. The tests, however, are initiated as objects. One object is initiated for the NBNA class, another for the NANB class. The configuration of the SUT as well as the driving and monitoring of stimulus is performed inside the test classes. The test classes also contain tasks for self-checking received messages against messages that have been sent. A test is run inside a test object until all messages are received or until a timeout error occurs. The following code segment illustrates how the top module declares the test objects and starts the test. The top module contains an *initial* block with a test sequence that is easy to comprehend.

```
//Declare an object for each test
NANB test 1; //Node A to Node B
NBNA test 2; //Node B to Node A
initial
begin
  $display("Starting
                       Node A to Node B transmit
 test\n");
    test 1 = \text{new};
    test 1.run test();
  $display("Finishing Node A to Node B
  transmit test\n");
  $display("Starting Node B to Node A
  transmit test\n");
    test 2 = \text{new};
    test 2.run test();
  $display("Finishing Node B to Node A
  transmit test\n");
end
```

As can be seen in the code segment above, the object is created with a call to the constructor of the test class. In many programming languages the constructor initializes variables with default values. In this case, however, the variable initializations have been made in a separate package that is specific for the test. The main reason behind this decision is the amount of variables that are required by the five AXI interfaces of the test bench. In addition, for most variables zero suffices as a default value. The constructor is instead used for initializing two parametrizable arrays with data. The data inside the arrays is transmitted by the AXI4-Stream master agents to Node A during the run phase of the test. The arrays are two-dimensional – the first dimension represents the amount of transactions to be sent, the second dimension the amount of data words per transaction. In SystemVerilog such an array could be made to store transactions of variable data word counts. The second dimension would in such case be represented by a dynamic array. In this case, however, all transactions for a two-dimensional array have the same data word count that is defined in the constructor. The following code segment demonstrates how one array is filled with data.

```
//Initialize AXI4-Stream Master data array
for(int i=0; i<AXIS4 0 tx count; i++)</pre>
begin
  for(int j=0; j<AXIS4 0 beat count; j++)</pre>
  begin
     //Header
     if(j==0)
       AXIS4 0 tx data[i][j] = header of tx;
     //Data
     //Example:
     //(AXIS4 0 tx count=20,AXIS4 0 beat count=10)
     //AXIS4 \ \overline{0} \ \overline{tx} \ \overline{data}[0] = \{ 'h00\overline{1}, \ ..., \ '\overline{h}009 \}
     //AXIS4_0_tx_data[1] = { 'h101, ..., 'h109}
     //...
     //AXIS4 0 tx data[20] = { 'h1401, ..., 'h1409}
     else
       AXIS4 0 tx data[i][j] = (i*'h100)+j;
  end
end
```

In the code example above the first index of each transaction in the $AX-IS4_0_tx_data$ array is initialized with a header and the remaining indices are initialized with data words. In this case the data words are initialized according to the example in the commented section of the code segment. Randomization could also be used for initializing the data, and for a larger amount of transactions it would probably be favourable.

The actual test is started by the run_test() call in the test bench top module. The run_test task, which is defined in the *NBNA* class, spawns two threads – a test thread

and a timeout thread. The test thread additionally spawns three threads that are active for the duration of the test. The timeout thread, on the other hand, terminates the test after a predetermined amount of time has passed in simulation. The functionality described in this paragraph is implemented with the following code.

```
fork
begin
  //Test thread
  fork
 begin
    configure DUT();
  end
 begin
    Node A process();
  end
 begin
    Node B process();
  end
  join
  if (prio1 recv cnt == AXIS4 0 tx count &&
     prio0 recv cnt == AXIS4 1 tx count &&
     error cnt == 0)
    $display("TEST SUCCESSFUL.
     %d High priority messages received,
     %d Low priority messages received\n",
     prio1 recv cnt, prio0 recv cnt);
  else
    $error("TEST FAILED.
     %d High priority messages received,
     %d Low priority messages received\n",
     prio1 recv cnt, prio0 recv cnt);
end
begin
  //Timeout thread
  timeout();
  $error("TEST FAILED.
  %d High priority messages received,
  %d Low priority messages received\n",
  priol recv cnt, prio0 recv cnt);
end
join any
```

As can be seen in the code segment, the test is considered successful if the amount of high priority and low priority messages match with the amount of messages that were initialized in the arrays holding the test data for each priority. Additionally, the error count that is updated during the data comparison between sent and received messages

must be null. If the transaction counts do not match or if the error count differs from zero, the test is considered unsuccessful and an error message is printed. The same is true if the test does not finish within the time specified in the timeout task. The data comparison is performed in the Node A process task.

The Node_B_process and Node_A_process are, in order, the tasks that send and receive messages. They will from here on be referred to as the node tasks. The con-figure_DUT task is where all configurations are written to the nodes. The DUT configurations are written to each node concurrently, and in this case, a SystemVerilog event is used to synchronize the configuration commands of Node B with its node task that drives the stimulus. The task should wait until the node configurations are written before starting to send data. This information is made available to the task through the activation of Node B configuration event. The Node_A_process task, on the other hand, starts its activity at the moment the test is started. Both of the node tasks are based on functions provided by the AXI BFMs. The full syntax inside the tasks is not important in order to understand the functionality of the test, and therefore much of the code has been removed from the following code segments. The code segments represent the key features of the node tasks.

```
@(Node B configured);
#15000; //Wait for system to stabilize.
fork
begin
  //AXI4-STREAM MASTER 0 DRIVER
  //Thread for driving high priority
  //transactions from AXI4-STREAM master agent 0.
  for(int i=0; i<AXIS4 0 tx count; i++)</pre>
  begin
    #delay;
    for(int j=0; j<AXIS4 0 beat count; j++)</pre>
    begin
      wr transaction 0 =
        mst agent axis4 0 power.driver.
        create transaction
        ("MST AXI4-STREAM VIP 0 write tx");
      wr transaction 0.
```

```
set data beat(AXIS4 0 tx data[i][j]);
      wr_transaction 0.set delay(0);
      if(j==AXIS4 0 beat count-1)
        wr transaction 0.set last(1);
    end
  end
end
begin
  //AXI4-STREAM MASTER 1 DRIVER
  //Thread for driving low priority
  //transactions from AXI4-STREAM master agent 1.
  //Transactions sent as for AXI4-STREAM MASTER 0.
  //See for-loop above.
end
begin
   //AXI4 STREAM MASTER 0 MONITOR
   //Thread for monitoring high priority
   //transactions sent from
   //AXI4-STREAM MASTER 0 DRIVER
   while(mst_agent_axis4_0_tx_queue_size <</pre>
         AXIS4 0 tx count)
   begin
      mst agent axis4 0 power.monitor.
        item collected port.
      get(mst_agent_axis4_0_tx);
mst_agent_axis4_0_tx_queue.
        push_back(mst_agent_axis4_0_tx);
      mst agent axis4 0 tx queue size++;
   end
end
begin
   //AXI4 STREAM MASTER 1 MONITOR
   //Thread for monitoring low priority
   //transactions sent from
   //AXI4-STREAM MASTER 0 DRIVER
  //Transactions monitored as for
  //AXI4-STREAM MASTER 0.
  //See while-loop above.
end
join
$display("Node B Process finished\n");
```

The above code segment demonstrates how two AXI4-Stream drivers are used in master mode to drive data to the SUT, and how two monitors store the transactions that are sent to a queue. In this example the AXI4-Stream Master 0 Driver drives the high priority

messages at an time interval equivalent to the *delay* time-variable. The monitor for the same master agent stalls the execution of its while-loop with the get-statement until a transaction is sent from the driver. The Node_B_process task finishes once all transactions have been sent from the drivers and all transactions have been stored into the monitor queues.

The purpose of the Node_A_process task, as has already been stated, is to receive the messages and to do the comparison. For receiving the messages through the AXI3 interface, a thread must be spawned for a monitor, but one should also be spawned for a slave driver. In addition, a third thread is spawned for the data comparison, here referred to as the scoreboard thread. This thread utilizes methods of the AXI BFM package as it needs to extract the data payload as well as other information from the transactions that are received by the monitor. The code below demonstrates the key features of the Node_A_process task.

```
fork
begin
   //AXI3 SLAVE DRIVER
   //Thread for sending a reactive handshake
   //transaction to the DMA controller
   //of Node A.
   while (prio1 received + prio0 received <
         mst agent axis4 0 tx queue size +
         mst_agent_axis4_1_tx_queue_size)
   begin
       slv agent axi3 control.wr driver.
         get wr reactive (reactive transaction);
       fill reactive (reactive transaction);
       slv agent axi3 control.wr driver.
         send(reactive transaction);
  end
end
begin
   //AXI3 SLAVE MONITOR
   //Thread for monitoring the high priority and
   //low priority transactions received from the
   //DMA controller.
   while (prio1 received + prio0 received <
         mst_agent_axis4_0_tx_queue_size +
         mst agent axis4 1 tx queue size)
```

```
begin
       slv agent axi3 control.monitor.
         item collected port.
         get (slv axi3 control monitor tx);
       slv agent axi3 control queue.
         push back(slv axi3 control monitor tx);
       slv axi3 control monitor tx cnt++;
   end
end
begin
   //SCOREBOARD
   //Thread for doing the comparison between the
   //transactions sent from Node B and the
   //transactions received at Node A.
   while (prio1 received + prio0 received <
         mst agent axis4 0 tx queue size +
         mst_agent_axis4_1_tx_queue_size)
   begin
   //1. Wait until a transaction is stored into the
       monitor queue of the AXI3 slave monitor
   //
   //2. Pop the transaction from the slave monitor
   //3. Extract the priority of the transaction from
   //
        the message header
   //4. Increment the counter corresponding to the
        priority of the received transaction
   //
   //5. Retrieve the data payload of the transaction
   //6. Compare the transaction content with
   //
        all transactions stored in the monitor queue
   //
        of the AXI4-Stream Master 0 or 1 of Node B
   //7. Update error counter. Print success/failure.
   end
end
join
```

In the code segment above the three threads run until each has received the correct amount of low priority and high priority transactions. If the transactions do not arrive, the test will be terminated by the timeout thread that runs concurrently with all test threads. In the above implementation the slave driver interacts with the DMA controller of the Node A by sending a handshake transaction to its AXI3 interface whenever a low or high priority transaction has reached the DMA. A successful handshake enables a further transmission of the low or high priority transactions from the DMA to the monitor queue of the AXI BFM. Whenever transactions are pushed into the queue of the monitor, they are popped from the same queue by the scoreboard thread. The scoreboard thread implements the prediction and the scoreboard activity as is demonstrated by the numerated sequence of events in the above code segment.

7 RESULTS

7.1 Results of the full IP test bench case study

In this case study the DUT was considered sufficiently tested once all tests were performed and the functional coverage was 100%. To reach full functional coverage the initial implementation for the coverage collector of the test bench had to be modified, as it was discovered early during the testing that simulation of the DUT would be time consuming. Large calculation window sizes with high downsampling factors resulted in computations that lasted for as much as one day. Corner cases for the computation configurations were therefore identified to ensure that critical features of the DUT would be tested. Additionally, the amount of coverage bins per computation configuration was reduced for configurations with a wide range of possible values. In order to achieve sufficient functional coverage, the constraints for the randomized stimulus also had to be modified. The functional coverage for the computation configurations are listed in Table 5 below. Unless otherwise stated, the bins for each computation configuration in the table are valid for both the DRMS and the SA co-processing modules.

Table 5. Functional coverage for each computation configuration. Bins representing ranges are represented as *minimum:maximum*. Due to time consuming simulations the amount of hits required per bin is simply one. It is however identified that the amount of required hits, especially for bins with a range of values, should have been larger.

Computation Configuration	Functional Coverage
Input Select	1 cover point with 4 bins : {0, 1, 2, 3} (0 = Idc, 1 = Icm, 2 = Debug input, 3 = Idc)
Calculation Window Size	1 cover point with 5 bins : {0, 1, 2:24998, 24999, 25000}
Downsampling Factor	1 cover point with 5 bins : {0, 1, 2:29, 30, 31}
Goertzel Algorithm Coefficient (17-bit signed, two's complement) Spectrum Analyzer only	1 cover point with 7 bins : {-65536, -65535:(-2), -1, 0, 1, 2:65534, 65535}

As demonstrated in Chapter 6.1.5, the computation configurations are actually crosscoverage items. However, for simplicity, the functional coverage of Table 5 has been represented in terms of the cover points corresponding to the data of each configuration. These cover points are crossed with the address of the register and the write enable signal.

The other coverage metric, code coverage, was also assessed for the DUT. Once 100% functional coverage was reached for the DRMS and SA co-processing modules, the merged code coverage was 92.5%. The code coverage could likely have increased even after 100% functional coverage was reached, however, at this point testing was no long-er continued. The merged code coverage is depicted in Figure 17.

Coverage Summary by Type:						
Total Coverage:					89.63%	92.50%
Coverage Type ◄	Bins <	Hits <	Misses <	Weight ◄	% Hit ◄	Coverage ◄
Statements	231	228	3	1	98.70%	98.70%
Branches	140	137	3	1	97.85%	97.85%
FEC Conditions	28	24	4	1	85.71%	85.71%
Toggles	3017	2673	344	1	88.59%	88.59%
FSMs	20	18	2	1	90.00%	91.66%
States	8	8	0	1	100.00%	100.00%
Transitions	12	10	2	1	83.33%	83.33%

Figure 17. The code coverage for the full IP test bench case study after 100% functional coverage was reached. The merged code coverage is 92.5%. Coverages higher than 90% are highlighted by the light green color cells.

Due to strict project timetables it was decided that while there would be a UVM test bench for the IP, a test bench written in VHDL containing some randomization would also be implemented by another person. This VHDL test bench would allow the designer of the IP to discover trivial bugs in the design before the more extensive tests with UVM would be performed. It is also for this reason that it is theorized that only one bug was found for the design during the UVM tests. The bug that was found occurred when the calculation window size was configured as 0. With this configuration the intended behavior for the DUT is to not start a computation. What the test showed was that the DUT started a computation and produced a result for the calculation window size 1. While this bug is not so serious, it proves that the initial work of defining corner cases for the DUT is crucial.

The design effort of the test bench is also a subject worth to discuss. For the full IP test bench directed test cases with randomization were implemented. Compared to purely directed test cases, where the stimulus is predefined and the output is known, the test cases of this case study were able to cover more DUT functionality. For example, the base test described in Chapter 6.1.4 is capable of covering numerous corner cases of the DUT that would have required plenty of directed test cases. Consequently, the amount of test cases is reduced. The design effort is, however, shifted towards the implementation of a predictor model, and this was also something that was discovered during the case study. In retrospect a lot of the challenges faced during the implementation and debugging of the predictor model were related to the synchronization between the DUT and the test bench. If, for example, a register in the predictor model is updated one clock cycle before the DUT, a faulty prediction will sooner or later occur during the tests.

Once the issues with the test bench were resolved and the testing could be started, the benefits of constrained random testing were clear. The simulations were running for long time periods without the need of human interaction. The testing was combined with a script that was able to switch between each test case and gather and merge coverages acquired from each test run. It is worth to note, however, that once an error occurred, the debugging process for a constrained random test case implemented in UVM is greater than for a purely directed test.

7.2 Results of the divide and conquer method

What is of particular interest for this case study, compared to the full IP test bench case, is whether the testing can be considered more extensive or not. The functional coverage for the computation configurations was the same as for the full IP test bench, but as mentioned in Chapter 5.3, additional functional coverage items are required for events. In this case study functional coverage items for the *reset* and *enable_IP* signals were implemented. Another event for which functional coverage items could have been written is the concurrency function in Table 2. In the full IP test bench case study concurrency was tested with a dedicated test case. While it is most certain that the DRMS and SA co-processing modules are active simultaneously in the fully randomized test, there is no guarantee that both co-processing modules start or complete a computation at the exact same clock cycle. This is a corner case that not only requires a functional cover-

age item, but also an effort in writing randomization constraints. These operations were not implemented in this case study, but they will be discussed in Chapter 8.

In terms of design effort, the complexity of the predictor model for the divide and conquer method can be considered equal to the full IP test bench, if not easier. The fully randomized test of this case study did not need to implement the register model of the DUT that was required for the full IP test bench. However, the randomized test cases of the full IP test bench had already been designed in a manner that required an accurate synchronization between the DUT and the test bench. Therefore, almost all of the predictor functionality had been designed by the time the divide and conquer case study was performed. For the coverage collector, however, the effort was higher than for the full IP test bench. As DUT events often occur as a result of transactions from multiple agents in the test bench, conventional cross-coverage between cover points is not sufficient. In SystemVerilog, cross-coverage can be implemented within a cover-group that consists of cover points. However, a cover-group is tied to one sequence item class, which means that a cover-group only measures functional coverage for one agent. DUT events therefore require explicitly written functions in the coverage collector that must be implemented by the designer. Although an explicitly written cross-coverage item was written for the reset condition, it would likely have been much easier to implement as a SVA property that is covered and asserted. The inclusion of assertions and cover properties will be discussed in Chapter 8.

The degree of automatization introduced by the divide and conquer method of this case study is comparable to the full IP test bench. In both cases coverage of multiple test runs is likely to be merged into one final coverage report with a script that automates the task. The full IP test bench might require human interaction when one test finishes and another should be started. That is, unless there is a script that automatically handles the task. For a fully randomized test, on the other hand, the designer might have to modify the randomization constraints if there are events that still haven't occurred during the simulation. For this task it is not very likely that an automated solution is found. What is true for both the full IP test bench and the divide and conquer method is, that once an error is encountered, the debugging will be a time-consuming task for the designer. For the fully randomized test there might be an additional effort in examining the exact conditions that led to the error.

When 100% functional coverage was reached by the test of this case study, the code coverage for the user logic submodule was somewhat less than for the full IP test bench. This was a little surprising as the opposite was predicted prior to implementing the case study. However, one of the major causes for this smaller figure proved to be a design modification that introduced four new FEC conditions to the design. These FEC conditions remained uncovered as they were dependent on generic values that were fixed by generic mappings within the design. As can be seen in the uppermost table in Figure 18, the merged code coverage for the user logic module of the IP-block was 91,95%. Had it not been for the four new FEC conditions the merged code coverage would have been over 93%. Figure 18 also depicts the merged code coverage from the full IP test bench case study in the lower table.

As there had already been two testing processes for the DUT, one with a VHDL test bench that included randomization and another with the full IP test bench, it was perhaps not so surprising that no bugs were found. The process of building the fully randomized test bench with the architecture depicted in Figure 13 did however reveal some good practices for future tests. The increased modularity of the test bench architecture used in this case study proved to be more practical than the one depicted in Figure 11. For example, separating the current interfaces into two agents made it easier to write sequences for each interface. It was also more intuitive to have only one active thread in the monitor of each agent. A reset agent was also introduced in this test which was beneficial for creating separate reset sequences for the initial reset and for random resets during the test.

Coverage Summary by Type:							
Total Coverage:						96.07%	91.95%
Coverage Type ◄	Bins 🖪	Hits <	Misses <	Weight 🚽		% Hit ◀	Coverage ◄
Statements	184	182	2		1)	98.91%	98.91%
Branches	105	103	2		1)	98.09%	98.09%
FEC Conditions	32	24	8]	1	75.00%	75.00%
Toggles	2078	1997	81		1)	96.10%	96.10%
FSMs	20	18	2		1)	0.00%	91.66%
States	8	8	0		1	0.00%	100.00%
Transitions	12	10	2	1	1	33.33%	83.33%

Recursive Hierarchical Coverage Details:

Total Coverage:					96.03%	94.06%
Coverage Type ◄	Bins <	Hits <	Misses <	Weight <	% Hit ◄	Coverage <
Statements	177	175	2	1	98.87%	98.87%
Branches	111	109	2	1	98. 1 9%	98.19%
FEC Conditions	28	24	4	1	85.71%	85.71%
Toggles	2086	2000	86	1	95.87%	95.87%
FSMs	20	18	2	1	90.00%	91.66%
States	8	8	0	1	100.00%	100.00%
Transitions	12	10	2	1	83.33%	83.33%

Figure 18. A comparison between the achieved code coverages at 100% functional coverage for the user logic submodule of the DRMS and SA Co-Processing IP. The upper table is derived from the divide and conquer case study and the table below is a recursive hierarchical code coverage representation from the full IP test bench. As small changes were made to the design after the full IP test bench case study, some bin counts differ. Coverages higher than 90% are highlighted by the light green color cells.

7.3 Results of the system level test case study

Compared to the UVM test benches of the IP block level case studies, the purpose of the system wide test bench of this case study was different. As the test bench of this case study was a lot less complex it was also earlier available. This proved to be beneficial during the design process as trivial bugs in the IP blocks were found early. Several bugs were found or confirmed while using the test bench. The test bench revealed, for example, that buffer multiplexing of the Bridge Interface IP in Node B was faulty, which in turn led to corrupted data payloads in transactions sent from Node B to Bode A. There were also cases of abnormal behaviors for the SUT that had been encountered in hardware testing that were confirmed as bugs in simulation. Such a situation occurred for the DMA controller of Node A when one of its buffers became full. Although there were still several buffers that were available, the DMA controller was not able to give access to these for transactions arriving from Node B. The DMA controller, in other words, caused a deadlock in the systemwide communication. Both of the bugs mentioned in this paragraph were observed while running the NBNA-test. The aforementioned bug was discovered as there were mismatches between sent and received transactions. The latter bug was discovered as the timeout thread of the test bench terminated the test and raised an error.

Results in terms of the objectives stated in Chapter 5.2 are harder to assess, as they are more subjective. The test bench that was implemented does however present a model for how object-oriented SystemVerilog test benches can be implemented. The modularity of the test bench could have been further improved by splitting the threads of the node process tasks into separate classes. This is true especially for the scoreboard threads, which might require further tasks and functions that would best be placed into a separate source file.

The directed tests that were performed for the SUT were able to discover some trivial bugs, but there was still a feeling that the system should have been tested more extensively. Randomizing the amount of transactions, the delay between them and the length and content of their data payloads are a few things that come to mind. While this should in theory have been performed already on the IP block level, it would still not have given the same confidence in the system wide design as the tests of this case study would. Another observation was that once again, as for the IP block level tests, much time was spent debugging when an error occurred. Because the stimulus of the tests was directed, it was easier to identify the condition that led to an error. However, inspecting the waveforms of the interfaces between the IPs in the SUT is inefficient and should probably instead be automated by concurrent assertions that monitor the interfaces. Assertions in the context of this systemwide test bench will be discussed in Chapter 8.

8 CONCLUSIONS

In this thesis the verification capabilities of SystemVerilog and CRV have been evaluated. In Chapter 2 three studies were reviewed in order to establish the expectations for this thesis. Keithan et al. (2008) described a great improvement in testing, especially as new obscure bugs were found that would have been hard to find with the existing testing strategy of the team. In this thesis merely one bug was discovered by the UVM tests, but on the other hand, tests had already been performed on the DUT once the UVM test benches were operational. The bug that was found could have been found by a directed test as it was caused by a corner case configuration. The DUT of the UVM case studies does, however, arguably implement a fairly unambiguous co-processing operation without complex control logic. The benefit of constrained randomization for finding obscure bugs remains undemonstrated, nevertheless, it would be interesting to examine in future research for designs with more complexity.

The findings by Ihanajärvi (2016) were confirmed in this thesis. CRV undoubtedly has the potential of yielding high code coverage and functional coverage, however, the creation of a fully functional CRV test bench is unarguably time consuming. As Ihanajärvi estimated in his work (2016), the verification process of this thesis is also likely to have consumed over 50% of the total time spent on system implementation for the DUT of the UVM case studies. Before this thesis no CRV test bench implementation had previously been tried at the company. The UVM evaluation therefore required the creation of the low-level verification components that would ideally be available at any time a verification process is started. Nonetheless, even with these reusable verification components available, a CRV test bench requires that a set of DUT-specific components, such as the coverage collector and the predictor model, are designed and fully debugged.

During the UVM case studies the synchronization of low-level DUT events with their corresponding test bench events were particularly challenging and time consuming to implement, as had been documented by Francesconi et. al. (2014). It is suggested that simple directed tests should first be performed to establish the correctness of simple DUT features as well as the test bench. These tests could also be performed with a fully

randomized test case that is constrained to stimulate the design with trivial input. However, other methods for quickly receiving feedback of the validness of a DUT's behavior should also be considered. Assertion Based Verification is one approach. Foster et. al. describe assertion patterns that could be used for recurring digital design features (2010: 161-210). Such assertions could be modeled for internal DUT features by the designer himself, thereby potentially revealing the root causes of bugs once they occur.

As one of the objectives of this thesis was to evaluate the use of SystemVerilog for verification, the object-oriented approach and high-level programming features of the language were also of interest and should be discussed. In the case study for the system level test bench modularity of the architecture was achieved by splitting test bench functionality into separate classes. Within these classes tasks were separated into the ones writing the configurations and the ones driving stimulus and receiving response. The execution in the latter type of tasks was additionally split into multiple threads that utilized third party SystemVerilog AXI BFMs. The threads in these tasks essentially represent a test bench in which some of the de-facto standard verification components presented in Chapter 3.1.3 interact concurrently with the DUT. The high-level programming features of SystemVerilog, such as the different array types of the language, were also useful for handling the transactions on the transaction level.

The test bench structure was not only considered in the system level test bench, but also in the UVM case studies. UVM does offer standardized classes for building a test bench, however, the exact implementation of these classes may still vary. In the case study for the divide and conquer method, which was the latter of the UVM case studies to be implemented, modularity was increased as the current interfaces were split in two, a reset agent was modeled and the predictor model was done separately of the scoreboard. The clock synchronization of the predictor model was also moved to the monitors in an effort to make a transaction level predictor model. The structure of the resulting test bench architecture in the divide and conquer case study was indeed preferable to the one used for the full IP test bench. The UVM case studies demonstrated two approaches to CRV testing. For the full IP test bench multiple test cases aimed at specific DUT requirements were modeled. Part of the reason for doing so was the lack of visibility into the DUT, which in turn would have required more design effort for the test bench if one fully randomized test case had been designed instead. The divide and conquer method, on the contrary, was modeled for the user logic of the DUT and was implemented as one fully randomized test case. One of the main issues with the divide and conquer method is that verification components need to be designed for a set of signals that will not be present in a system level design. In the full IP test bench these signals receive their values through the user registers, which in turn have been configured by an interface that is in system-wide use, in this case the MMUR-interface. It should perhaps instead be considered if the internal signals necessary for the self-checking should be read through a hierarchical access into the DUT. Another benefit of accessing internal signals of the DUT is that certain events can be monitored more carefully. For example, an overflow condition for a FIFO could be monitored by binding a test bench signal to the *full* signal of the FIFO, which would allow for functional coverage to be written for this event.

In the UVM case studies of this thesis constrained randomization has been used for the randomization of DUT configurations, but also for the randomization of event occurrence. Testing has been implemented as either a set of dedicated test cases or as one fully randomized test case. With the knowledge that has been gathered throughout the case studies of this thesis, it is now the belief that if desired, a fully randomized test case could also be implemented for a full IP-block. This would likely require, as stated in the previous paragraph, that some of the internal signals of the DUT are accessed hierarchically. However, as discussed in Chapter 5.3 and 6.1.6, the fully randomized tests require that the occurrence of events must be measured using functional coverage. In Chapter 6.1.6 the method of measuring events by using cross-coverage is described, but it requires design effort and changes to the structure of the test bench. A better solution would instead be to use the SVA subset of the SystemVerilog language in conjunction with internal signals of the DUT. In Chapter 3.2.1 an assertion is modeled of a *request-acknowledge* handshake. If, for example, the DUT would have to monitor that such an event occurs, a *cover* statement could also be made for the handshake property. Func-

tional coverage does not only have to be modeled using the cover-groups of SystemVerilog, and for DUT events temporal logic statements could instead be used.

Finally, the debugging effort related to the case studies should be discussed. In all of the cases a predictor model was implemented as a means of checking the validness of the DUT. For the system level test bench, with its simpler stimulus, not as much time had to be spent on debugging the predictor model as for the UVM tests. However, as stated in Chapter 7, it did uncover bugs in the design either through a mismatch between the predicted response and the actual response or through a timeout in the test. The design features for which the bugs were found are both good examples of design patterns for which assertions could have been written. The data mismatch in the test was caused by a faulty priority multiplexer that switched its input although the active transaction was still being sent. The timeout was caused by a deadlock in an FSM. Had assertions been used on the IP-block level, the root cause of these design flaws would likely have been discovered immediately.

In conclusion, high code coverages were achieved with the CRV approach, as demonstrated in Tables 17 and 18, when functional coverage was sufficient. The UVM test benches did, however, require a high level of knowledge to be successfully implemented. Consequentially, the test benches were functional at a late stage of the development cycle. While CRV could be used to run exhaustive testing for design features that benefit from constrained random stimulus, other more agile testing approaches could perhaps be utilized during the development process of IPs and system wide designs. One such approach is Test Driven Development (TDD), in which verification is performed iteratively with small tests that incrementally cover the functionality of a DUT (Beck 2003: xii). TDD could benefit from the verification concepts introduced in this study by, for example, being used in conjunction with existing UVM agents to achieve transaction level modeling. Compared to a more conventional CRV approach, the initial tests would be more directed and functionality of the DUT would be incrementally tested. In addition, as TDD emphasizes the use of testing to support the design work, RTL level temporal statements and assertions could be designed that would gather functional coverage and check for design flaws. This would likely reduce the overhead for writing verification components such as the predictor model, the scoreboard and the coverage collector. Design features in the verification plan that require randomization could be run at a later stage of the testing, at which point most of the functionality of the design would already have been tested.

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